

ELEC2104 – Week 6

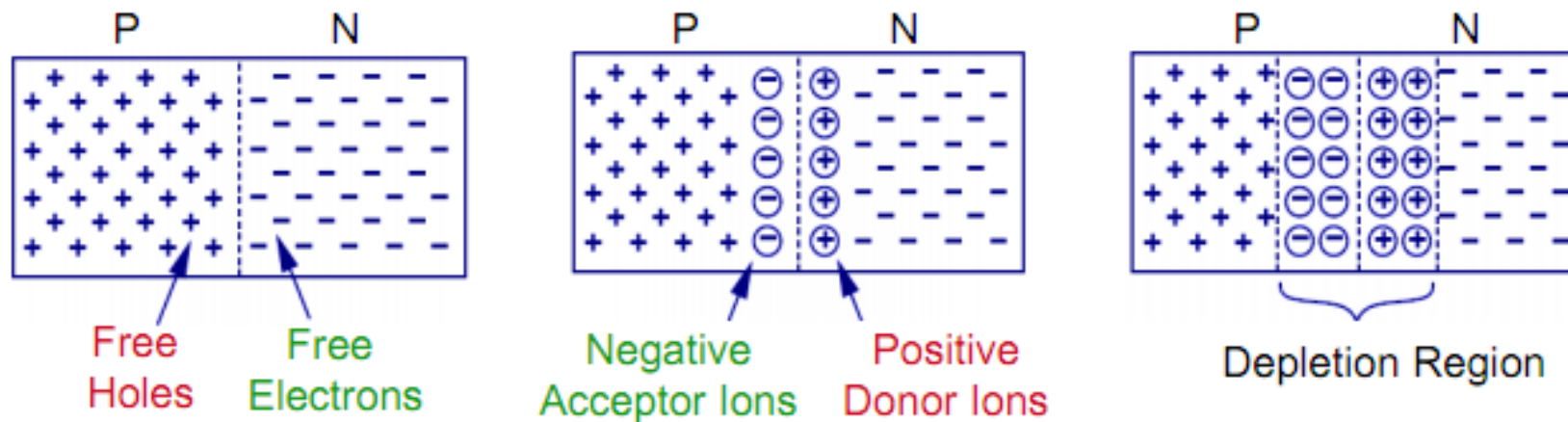
Bipolar junction transistors



THE UNIVERSITY OF  
SYDNEY

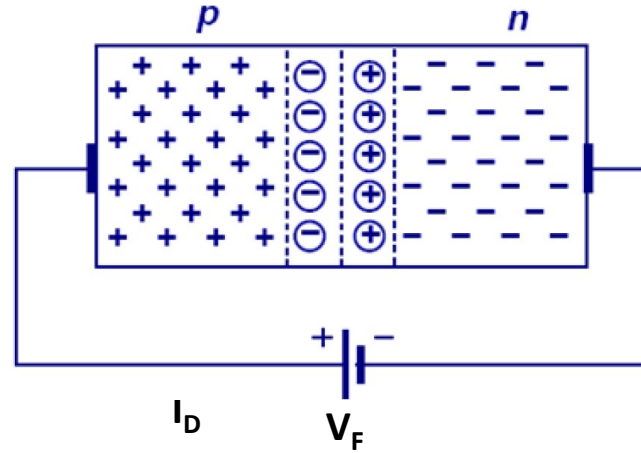
# PN Junction Review

- As free electrons and holes diffuse across the junction, a region of fixed ions is left behind. This region is known as the “depletion region.”
- The fixed ions in depletion region create an electric field, hence potential difference from p to n.
- Fermi level is flat if the device is not under external bias.
- With no external field applied, the drift current flowing in one direction cancels out the diffusion current flowing in the opposite direction



# PN Junction Review

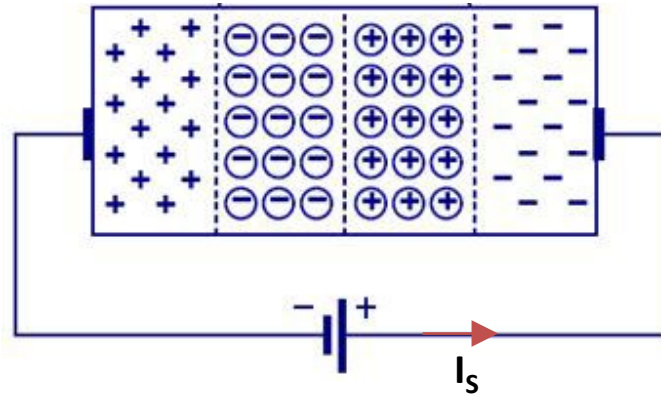
- Forward bias



$$I_D = I_S \left[ \exp\left(\frac{V_F}{V_T}\right) - 1 \right]$$

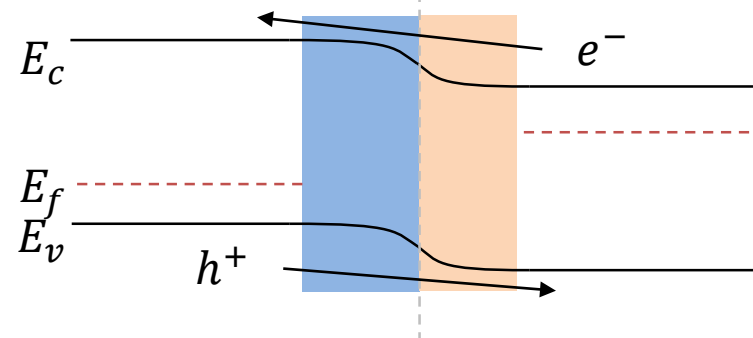
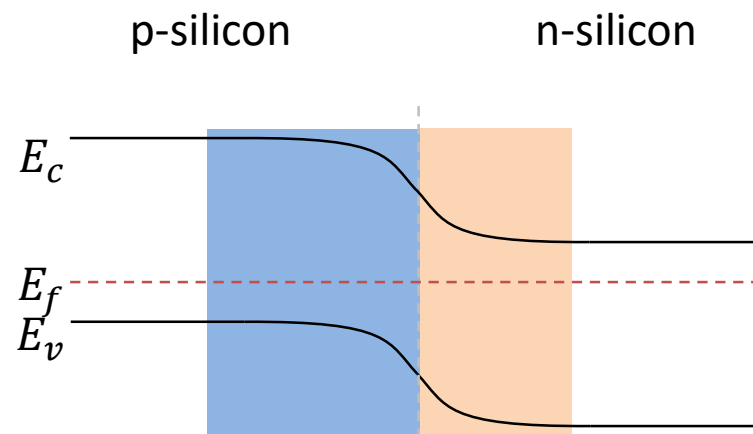
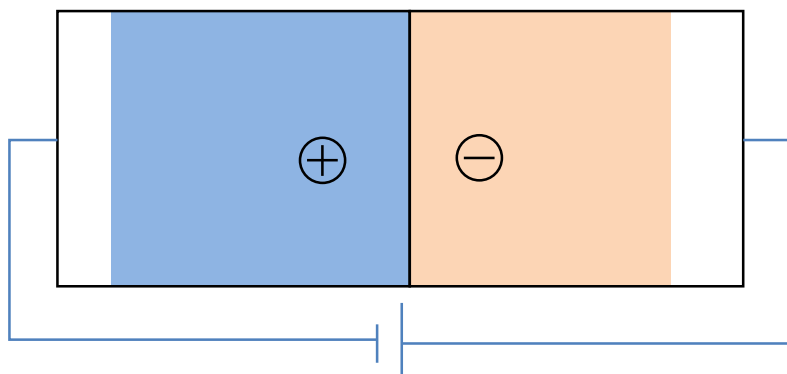
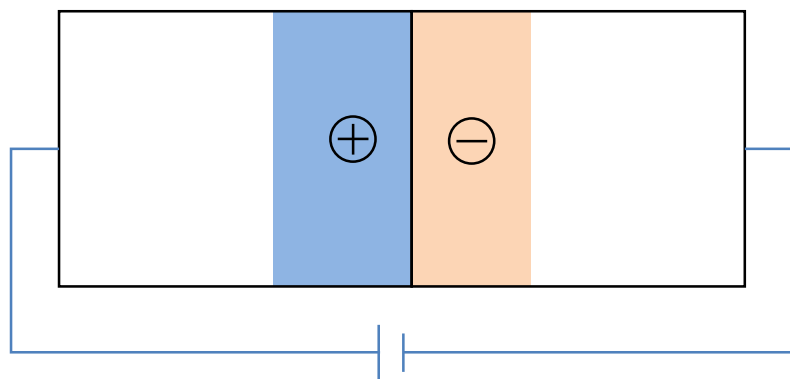
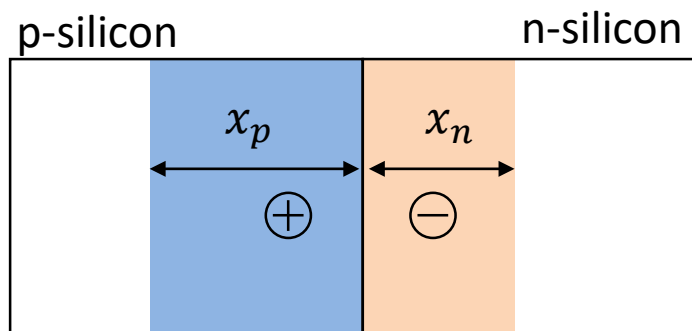
$$V_T = 26\text{meV}$$

- Reverse bias

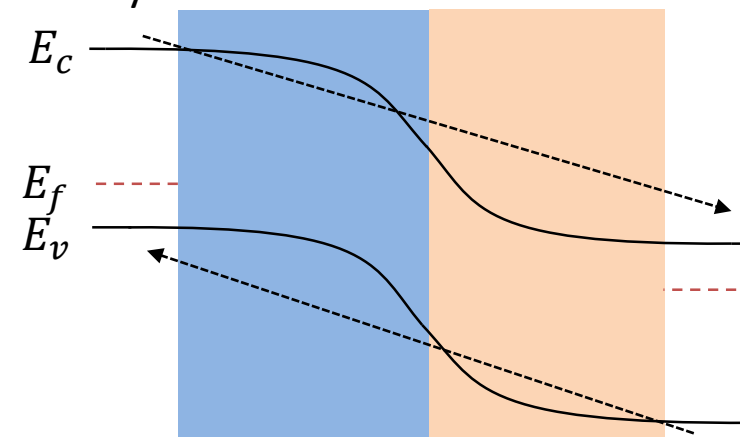


$$I_D = -I_S$$

Small current due to flow of minority carriers

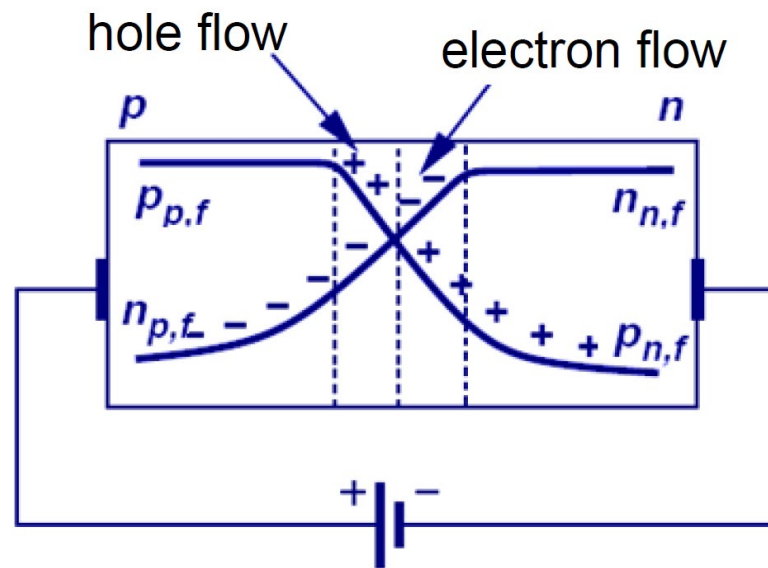


Not many  $e^-$



# I/V Characteristics in Forward Bias

- Recombination of the minority carriers with the majority carriers accounts for the dropping of minority carriers as they go deep into the P or N region



**Minority carrier concentrations must vary**

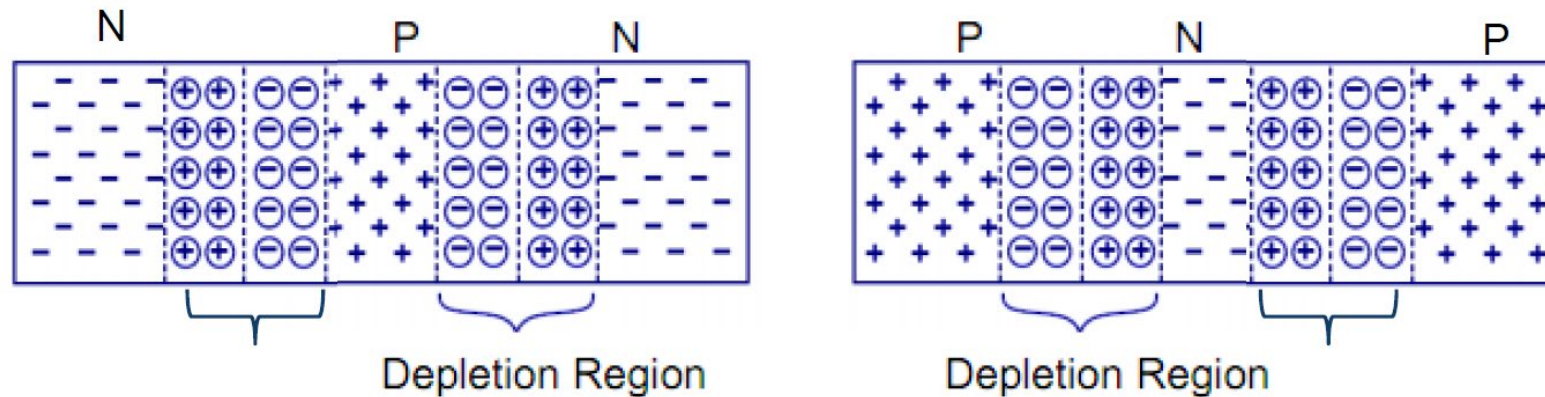
BJT

# Bipolar junction transistors (BJT)

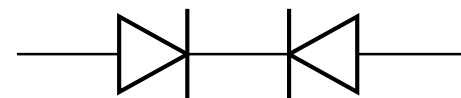
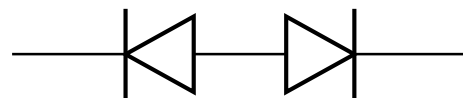
- Invented (1940s) before Field-effect transistors (FET)
- Three terminal device (you can control the circuit now)
- Most digital circuits use FETs
- BJTs are used when high speed, high precision, or high current scenarios
- Current driven (FET is voltage driven)
- npn has higher performance than pnp
- insulated-gate bipolar transistor (IGBT): important in electric cars.

# Bipolar Junctions

- We are going to append another doped semiconductor to the PN junction.
- This is called a bipolar junction
- Can be NPN or PNP



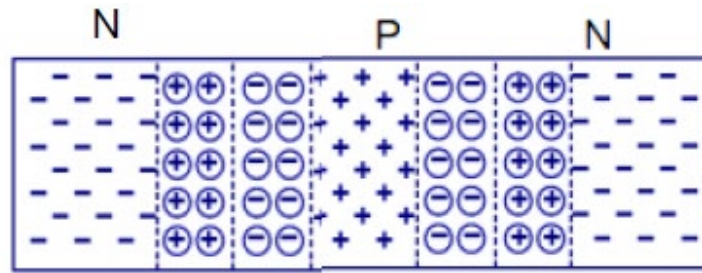
Are they just two PN diodes in series?



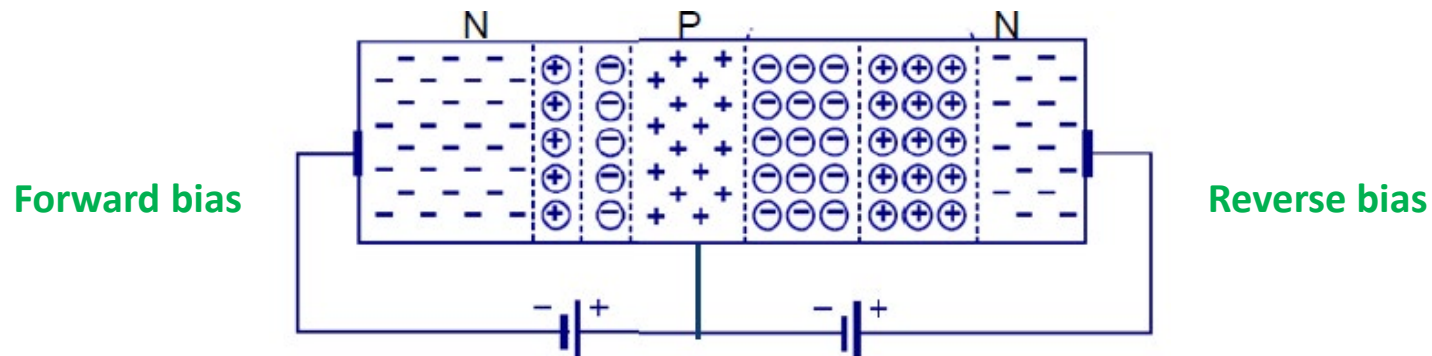


# Biased a bipolar junction

- Equilibrium: No voltages applied, diffusion currents cancel out drift current induced by built-in voltage at junctions.

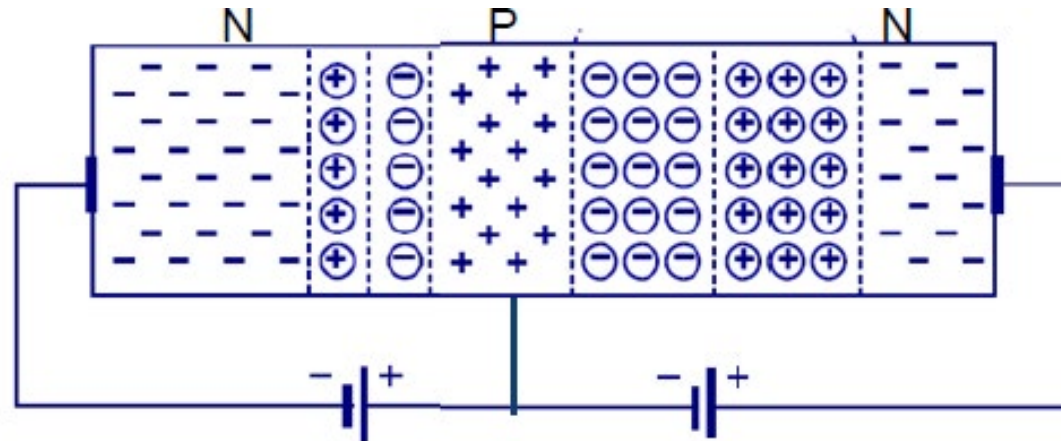


- What happens if we bias this device?
  - Apply a positive voltage across both junctions



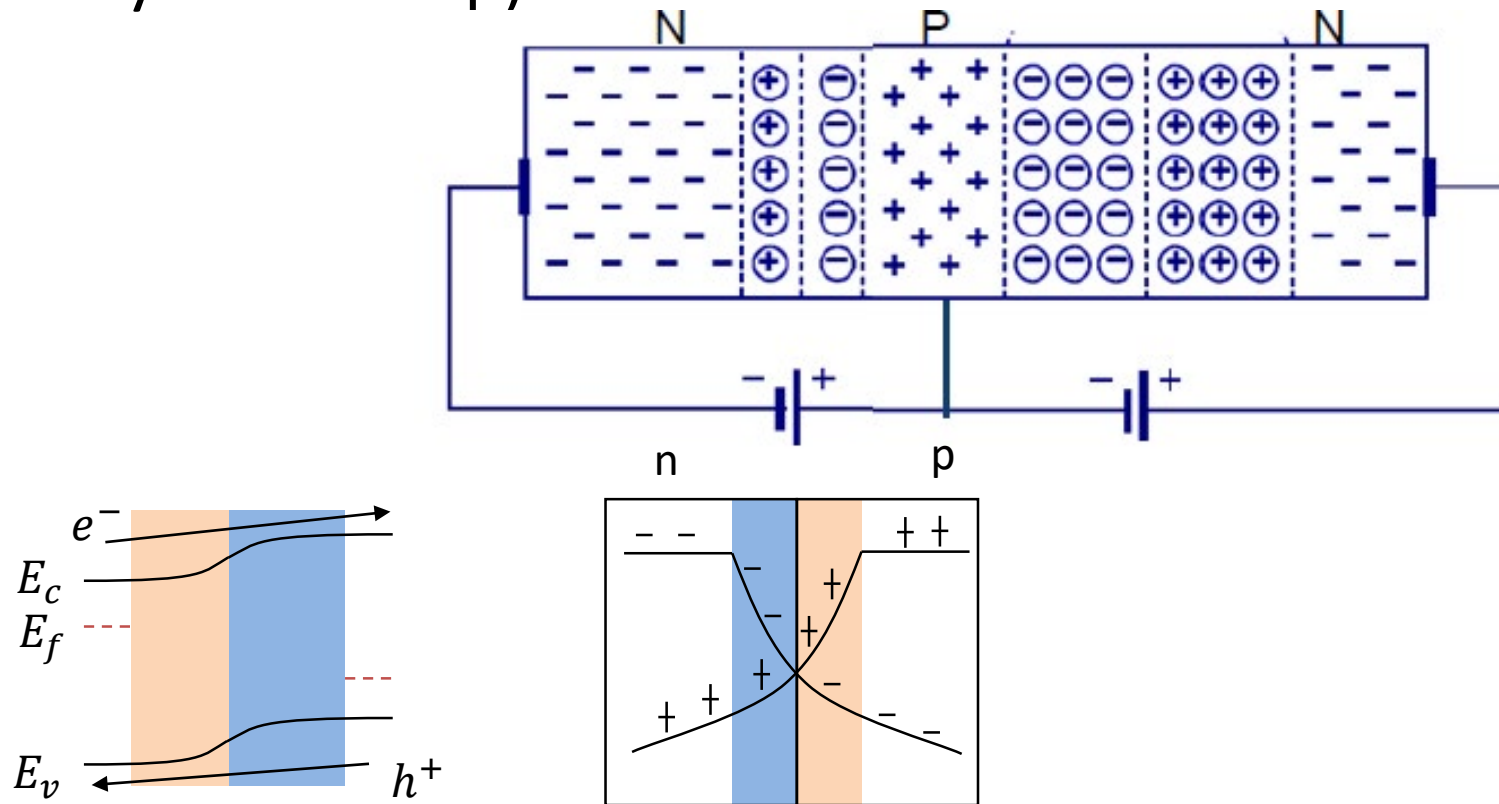
# Biased a bipolar junction

- One junction is forward-biased while the other is reverse-biased
- Examine what happens to a carrier from left to right:
  - The forward-biased junction is a diode that is on. Electrons move across the junction in the form of diffusion current
  - In the middle region, some electrons can combine with holes in the p-doped region



# At the emitter-base junction

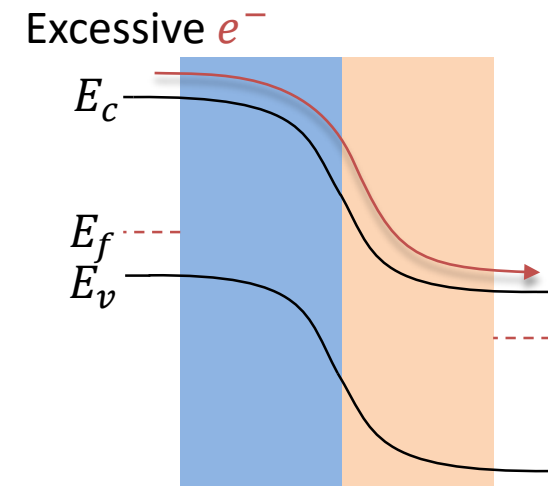
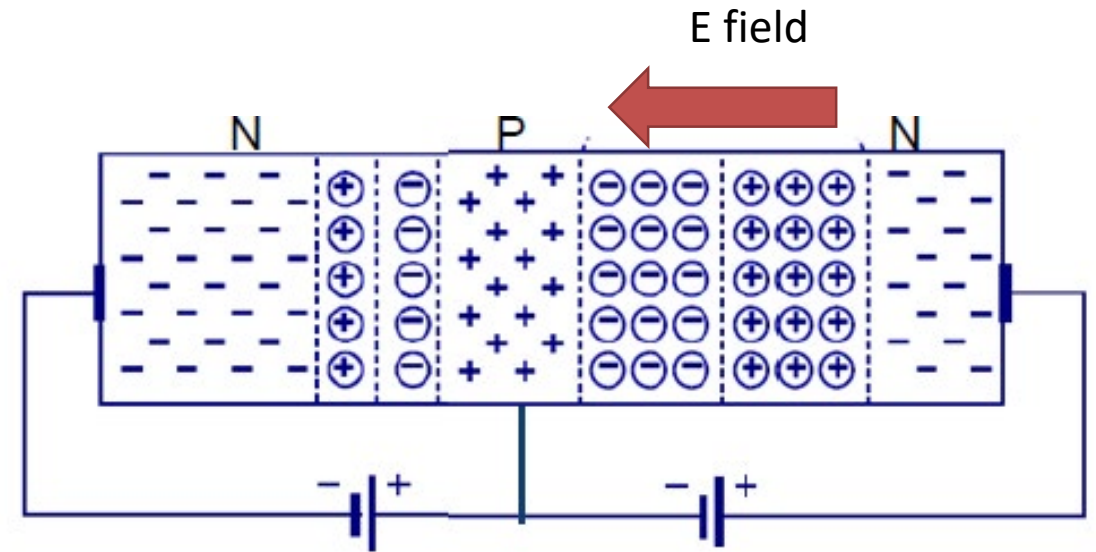
- Left side: some electron from n make it to p region (becoming minority carrier in p)



What happens to the free electrons that do not recombine with holes?

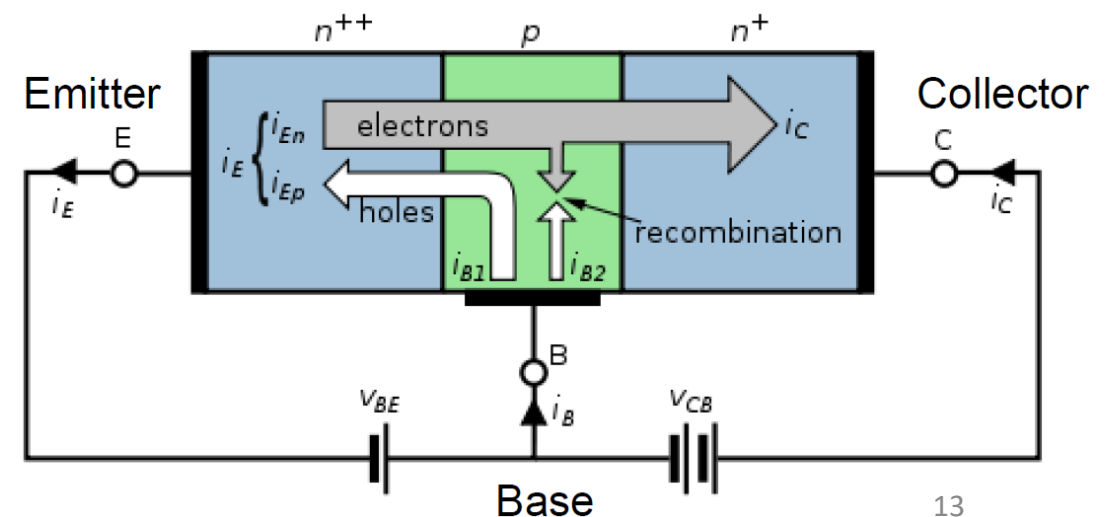
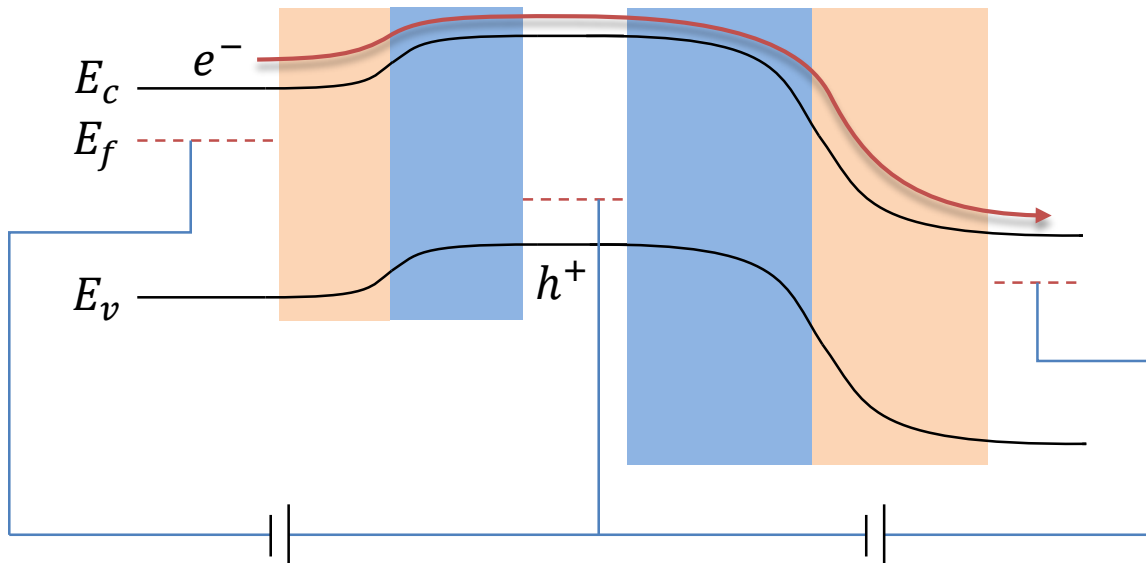
# At the base-collector junction

- Electrons made it to the pn junction on the right:
  - The built-in electric field in the pn junction on the right quickly collect the electrons to the n side.



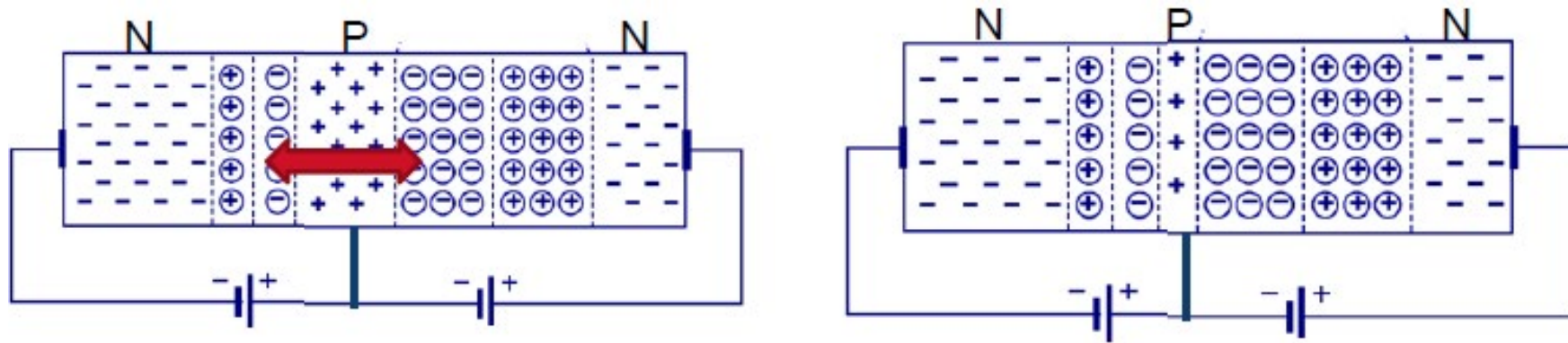
# Biassing a bipolar junction

- Remember, wires contacts “talk” to Fermi levels. Roughly speaking, they directly control the majority carriers. The base contact doesn’t talk to electrons here (minority carriers) directly.
- The p region is filled with holes, and its Fermi level is controlled by the base contact. The p concentration here is near constant. Even under bias, the energy levels and the Fermi level here appear to be almost flat.
- “Under the water”, the minority electrons secretly move across
- Of all the electrons made through the p region from the emitter, a small portion will recombine with holes, or they will go directly to the base contact
- The holes from base does diffuse to emitter, which causes another portion of the base current



# Better BJT

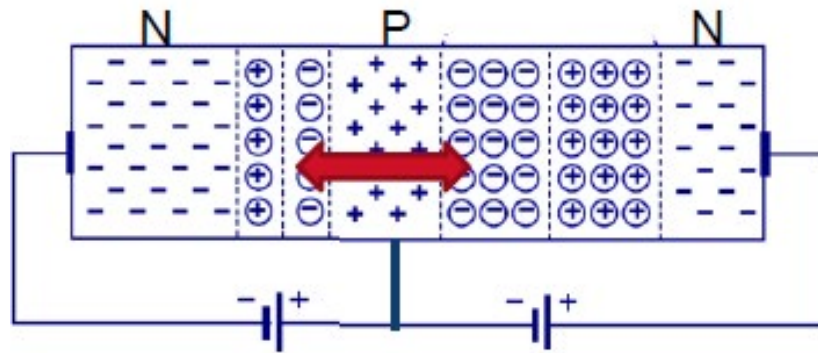
- We want this device to operate such that electrons (emitted) from the left side will enter the depletion region and be swept to (collected at) the right side of the n region before they have a chance to recombine with holes
- How to minimize the probability of an electron recombining with a hole?



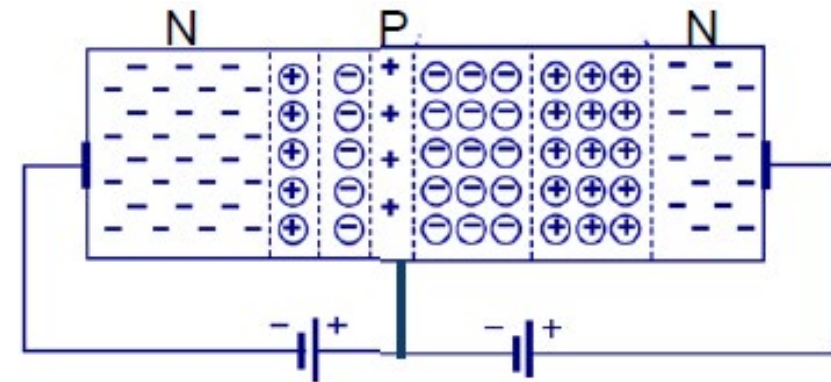
**Increase the probability of emitted electrons which travel toward the “collecting side”**

## $n^+$ emitter, thin base

- We want this device to operate such that electrons (emitted) from the left side will enter the depletion region and be swept to (collected at) the right side of the n region before they have a chance to recombine with holes
- How to minimize the probability of an electron recombining with a hole?



Left side n-type is made  
very heavily doped ( $n^+$ )

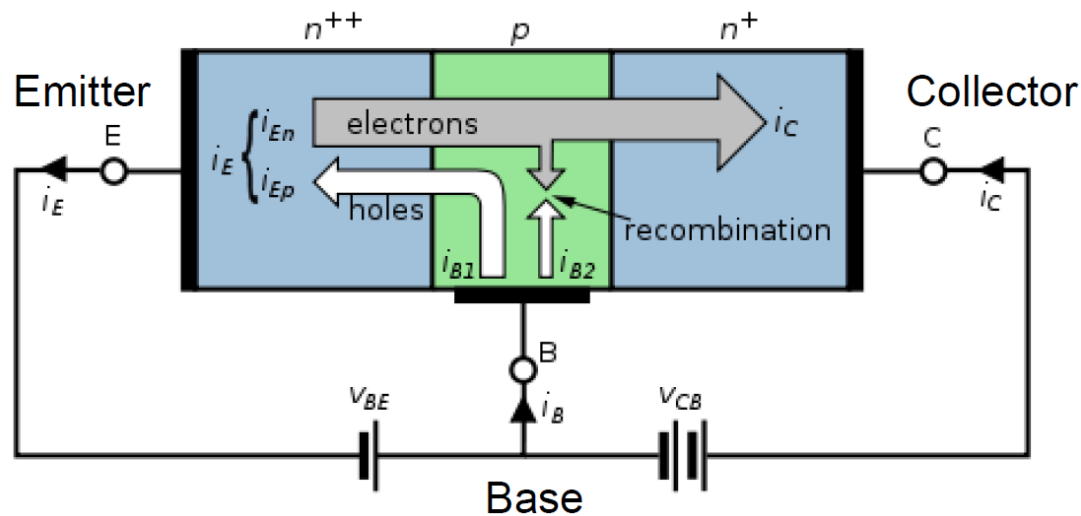


The middle region is made  
very narrow  
( $0.1\mu\text{m} \sim 100\mu\text{m}$ )

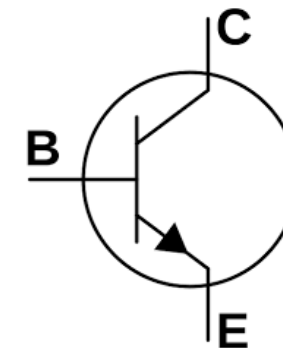


# Bipolar Junction Transistor

- This device is called a bipolar junction transistor (BJT)
- Regions: **Emitter, Base, Collector**
- In typical operation, the base-emitter diode is forward biased and the base-collector diode is reverse biased
- The emitter is usually much more heavily doped than the other regions



A small amount of current from the base can induce a much larger current from the emitter

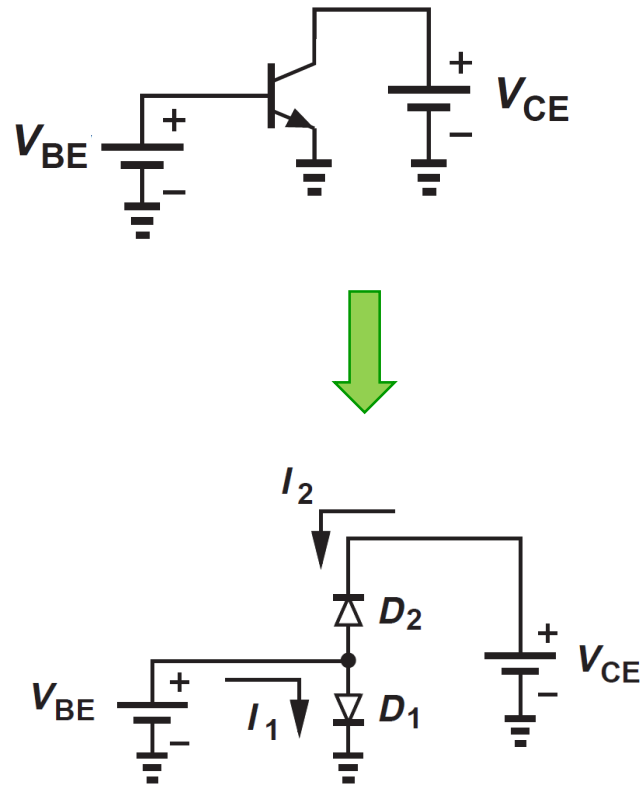


Symbol of a NPN BJT



# Bipolar Junction Transistor

- Is BJT the same as two back-to-back diodes?

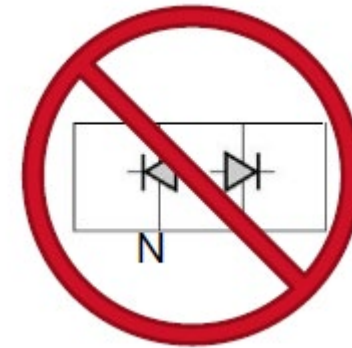
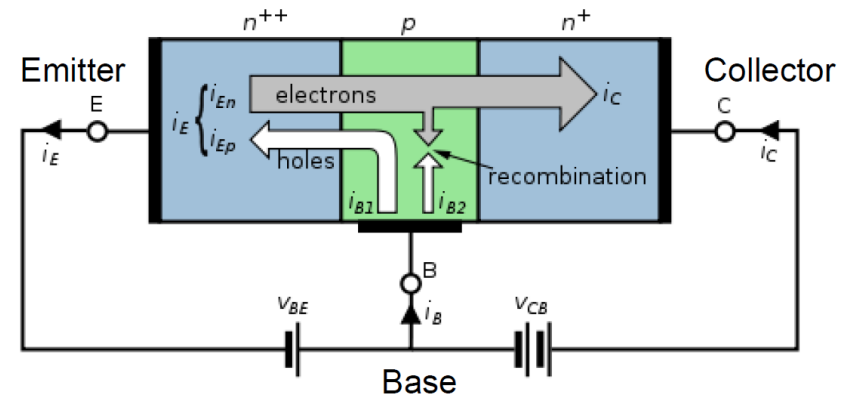
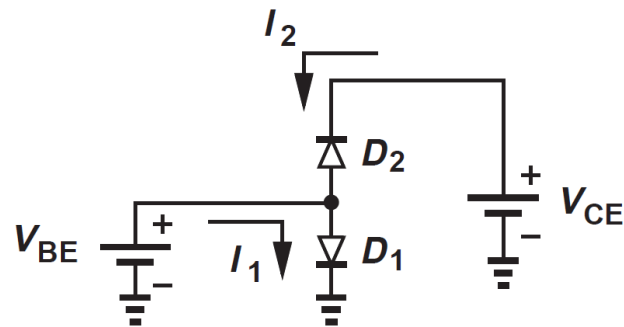
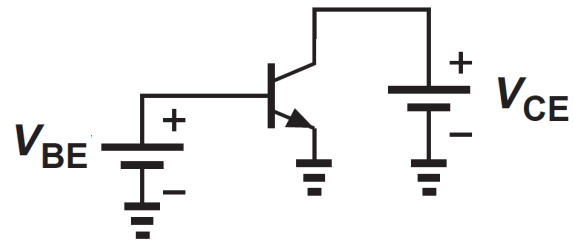


Does  $D_1$  carry a current?

Does  $D_2$  carry a current?

# Bipolar Junction Transistor

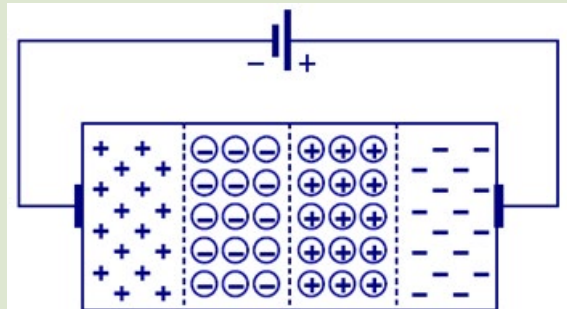
- Is BJT the same as two back-to-back diodes?



# Bipolar Junction Transistor

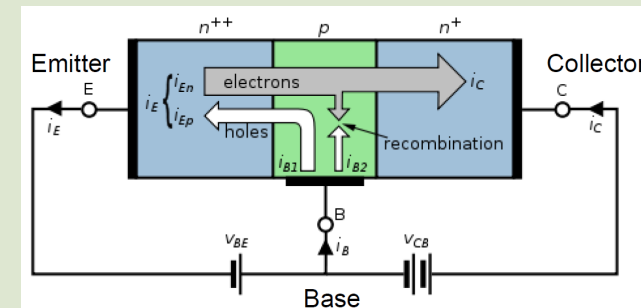
## Reverse biased PN junction

- Majority carriers that diffuse into the depletion region are pushed back to where they came from
- A reverse-biased diode by itself should only have a small reverse-saturation current  $I_S$  (assuming it is not in reverse breakdown).
- $I_S$  is a result of minority carrier drift.



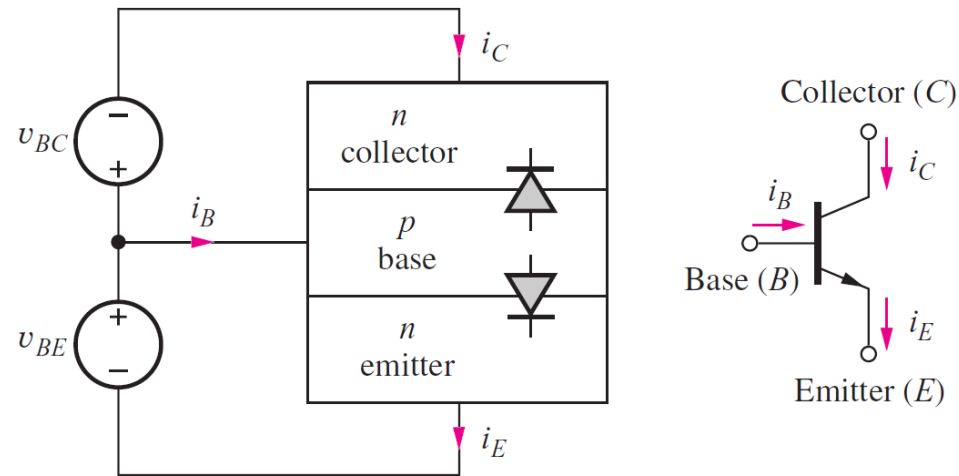
## Reverse biased PN junction in a BJT configuration

- The heavily doped emitter (N-type) provides a large amount of electrons
- These electrons diffuse into the lightly doped base (P-type) which forms a number of minority carriers
- The base is so narrow that these electrons get through before they can recombine with the holes



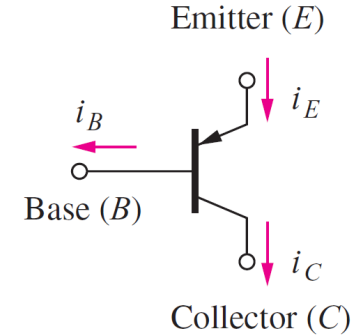
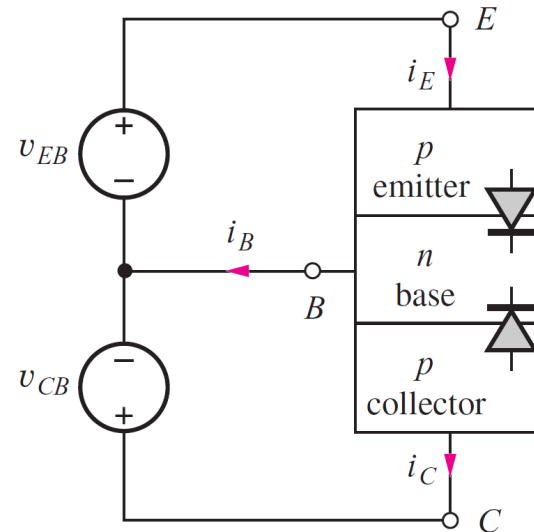
# NPN and PNP

- NPN and PNP transistors have the same functionality, different majority carriers.
- In typical circuits, NPN transistors have emitters connected to a lower voltage than the collector
  - Emitter is a source of electrons
- Emitter has an arrow because it is forward-biased

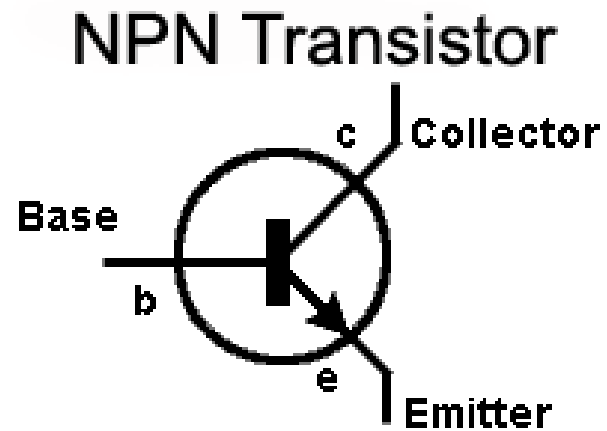


# NPN and PNP

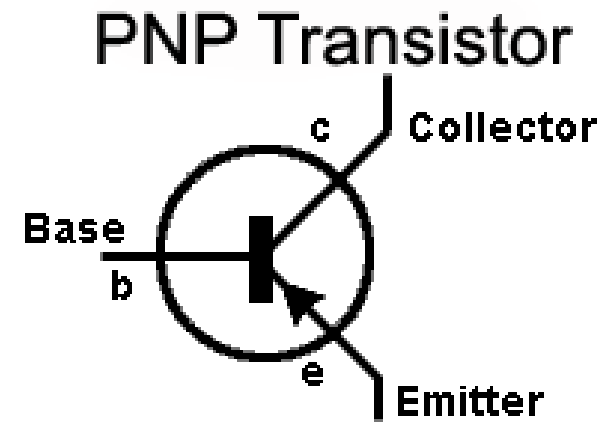
- PNP transistors are fabricated by reversing the layers of the NPN transistor
- Collectors connected to a lower voltage than the emitter
  - Emitter is a source of holes



# NPN and PNP



**N** **N**ever  
**P** **P**oints  
**N** **i****N**

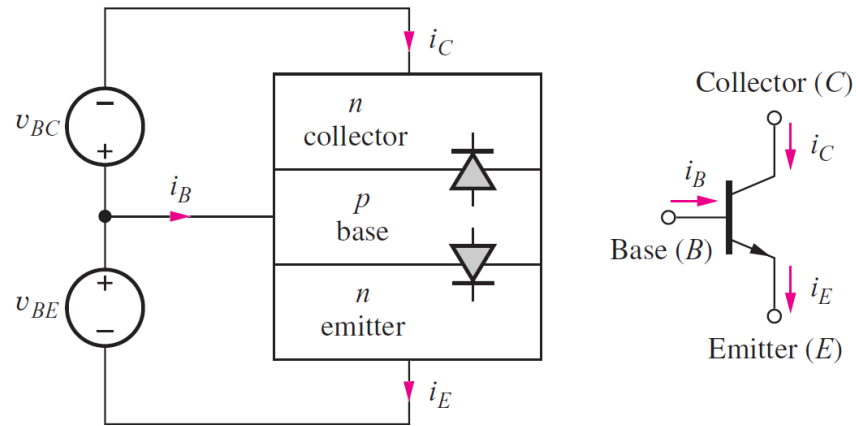


**P** **P**oints  
**N** **i****N**  
**P** **P**ermanently

# Transport in BJT

# NPN BJT Transport Model

- Emitter injects electrons into base region, almost all of them travel across narrow base and are removed by collector
- Base-emitter voltage  $v_{BE}$  and base-collector voltage  $v_{BC}$  determine currents in transistor
  - Positive when they forward-bias their respective *PN* junctions.
- Terminal currents: collector ( $i_C$ ), base ( $i_B$ ), emitter ( $i_E$ ).



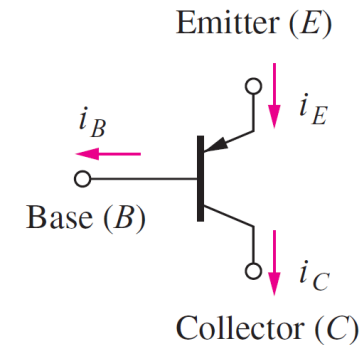
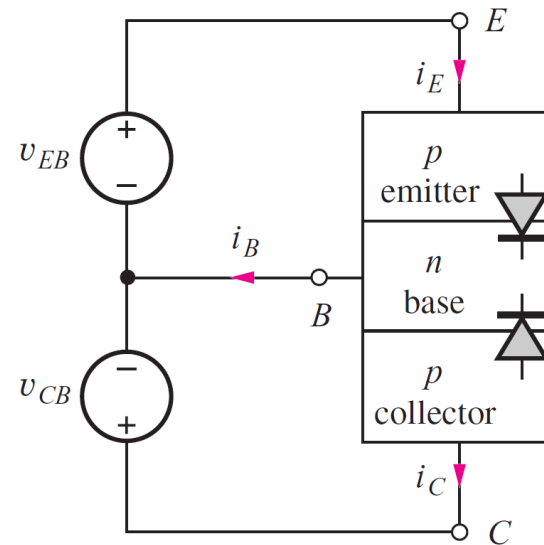
Note: Voltage subscripts denote positive-negative terminals



# PNP BJT Transport Model

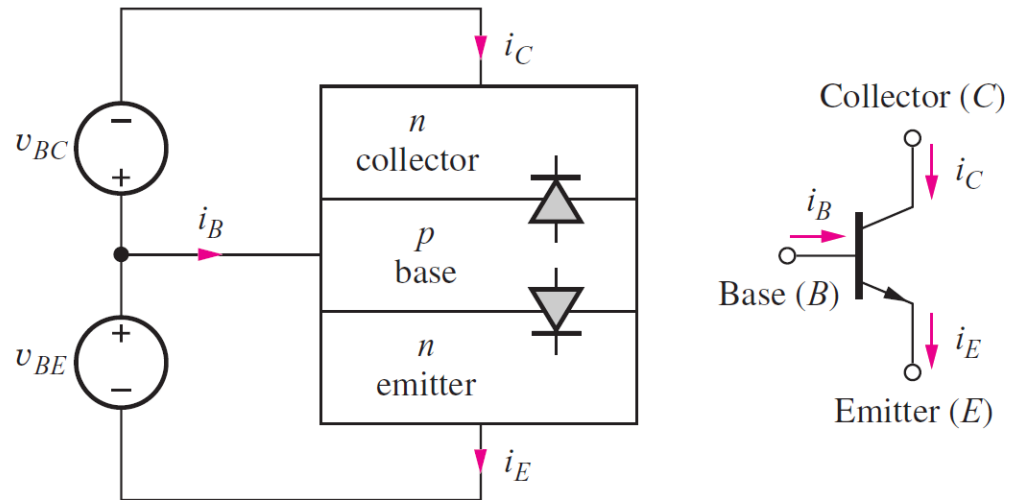
- Voltages  $v_{EB}$  and  $v_{CB}$  are positive when they forward bias their respective  $pn$  junctions.
- Collector current and base current exit transistor terminals and emitter current enters the device.

Attention to the sign



# NPN Forward Active Region

- NPN forward active region:  $V_{BE} > 0$ ,  $V_{BC} < 0$ .
  - Base-emitter is forward-biased, base-collector is reverse-biased
- This is the most frequently used mode
- The base-emitter voltage establishes the emitter current  $i_E$



# NPN Forward Active Collector Current

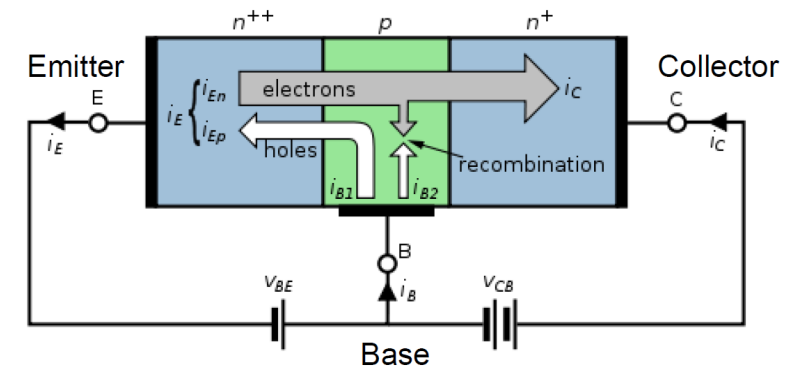
- **Forward transport current:** Current flow from collector is the same equation as the forward diode current for the base-emitter diode
- Simple way to remember what's going on:
  - In a pn-junction this current flows from n to p; here the  $V_{BE}$  is forward biasing the B-E pn junction, only that the electron current from emitter doesn't go to p contact (base), instead, it mostly go to the collector.
- The BJT can be understood as a voltage-controlled current source.

$$i_C = i_F = I_S \left[ \exp\left(\frac{V_{BE}}{V_T}\right) - 1 \right]$$

$$I_S = \frac{AqD_n n_i^2}{N_A W_B}$$

$$10^{-18} A \leq I_S \leq 10^{-9} A$$

$W_B$	width of base
$A$	area
$q$	elementary charge
$N_A, N_D$	acceptor and donor density
$D_n, D_p$	diffusion constants
$V_T = k_B T$	Thermal voltage
$k_B$	Boltzmann constant
$n_i$	intrinsic carrier density

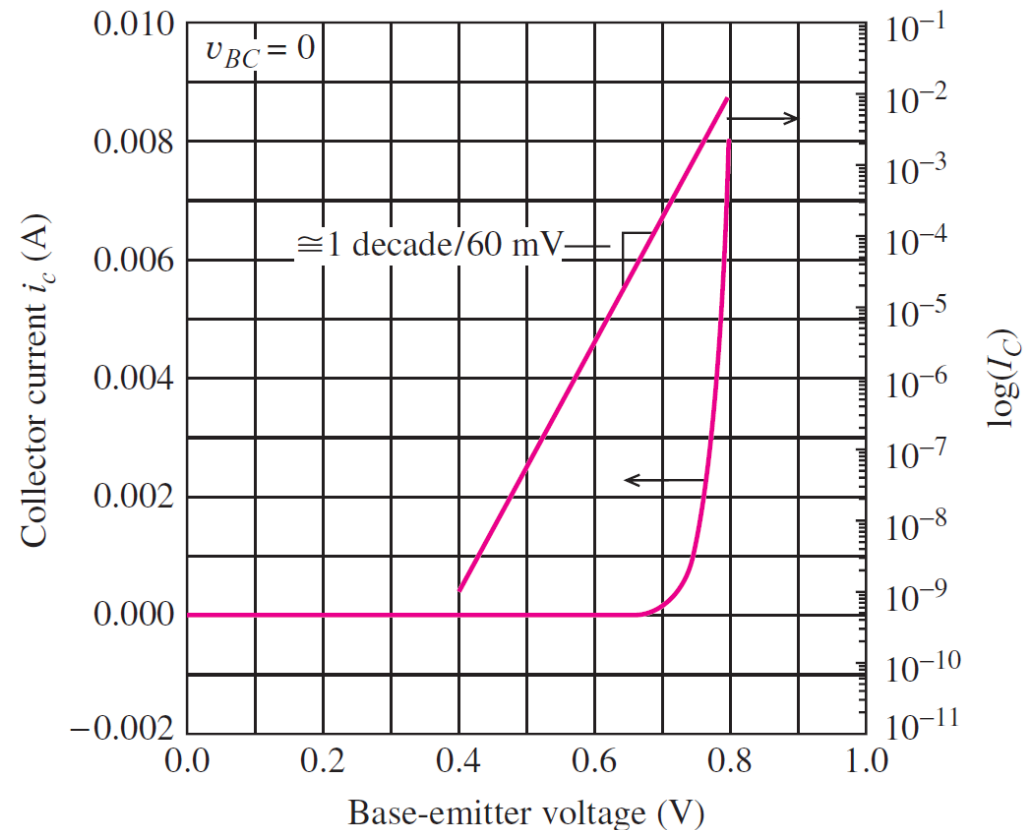


$I_S$  is transistor saturation current  
which is analogous to the diode's  
reverse saturation current

$$\longrightarrow I_S = Aqn_i^2 \left( \frac{D_n}{N_A L_n} + \frac{D_p}{N_D L_p} \right)$$

# NPN Forward Active I-V Characteristics

- Relation between collector current and base-emitter voltage of transistor
- Almost identical to transfer characteristic of *pn* junction diode



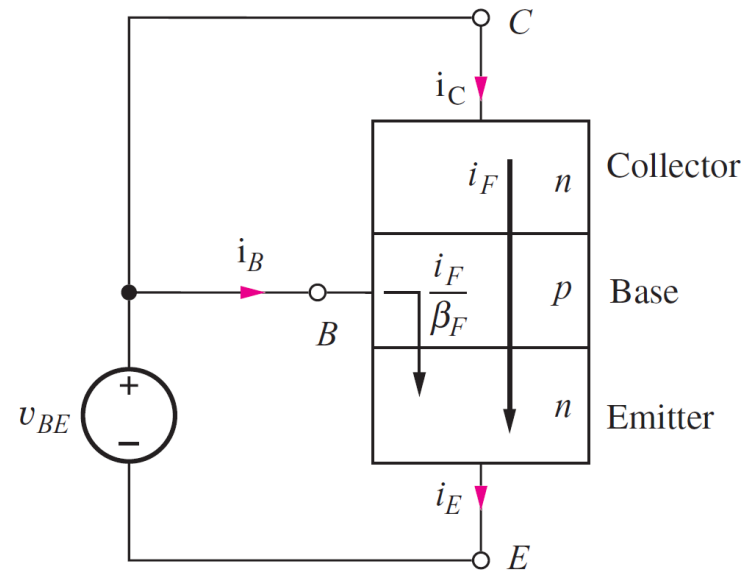
# NPN Forward Active Base Current

- **Base current:** Smaller current, which is proportional to collector current:

$$i_B = \frac{i_C}{\beta_F} = \frac{I_S}{\beta_F} \left[ \exp\left(\frac{V_{BE}}{V_T}\right) - 1 \right]$$

- $\beta_F$  is the forward **common-emitter current gain** and depends on the base width and emitter doping

$$10 \leq \beta_F \leq 500$$



$I_C$  is equal to  $I_F$   
which is the forward  
transport current

# NPN Forward Emitter Current

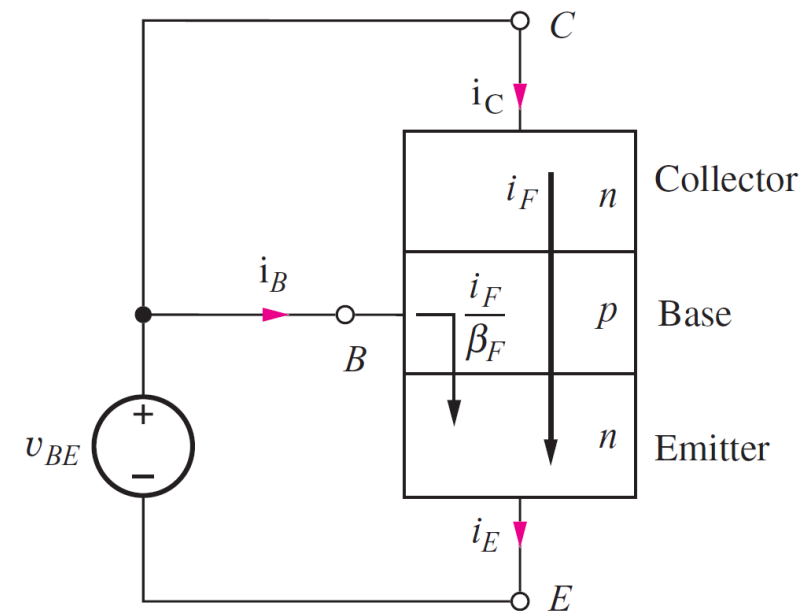
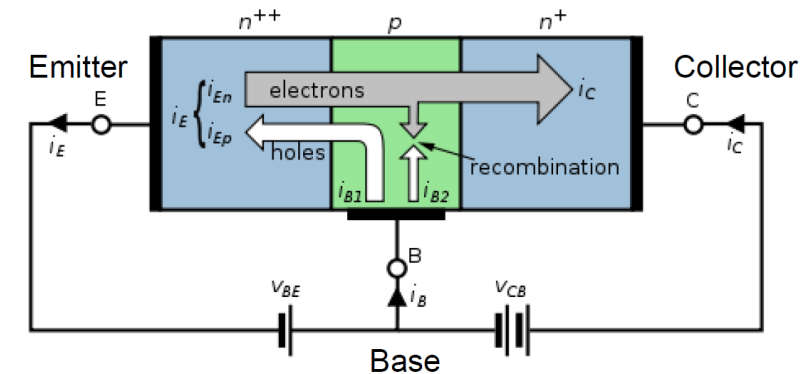
- By Kirchhoff's current law, emitter current is the sum of base and collector currents

$$\begin{aligned} i_E &= i_C + i_B \\ &= I_S \left( 1 + \frac{1}{\beta_F} \right) \left[ \exp \left( \frac{V_{BE}}{V_T} \right) - 1 \right] \\ &= \frac{I_S}{\alpha_F} \left[ \exp \left( \frac{V_{BE}}{V_T} \right) - 1 \right] \end{aligned}$$

- $\alpha_F$  is the forward **common-base current gain**:

$$0.95 \leq \alpha_F = \frac{\beta_F}{\beta_F + 1} \leq 1.0$$

$$\beta_F = \frac{\alpha_F}{1 - \alpha_F}$$



# Forward active current summary

- Transistor “amplifies” its base current by a factor of  $\beta_F (\gg 1)$ 
  - Injection of a small current into the base produces a much larger current in both collector and emitter terminals

$$\frac{i_C}{i_B} = \beta_F$$

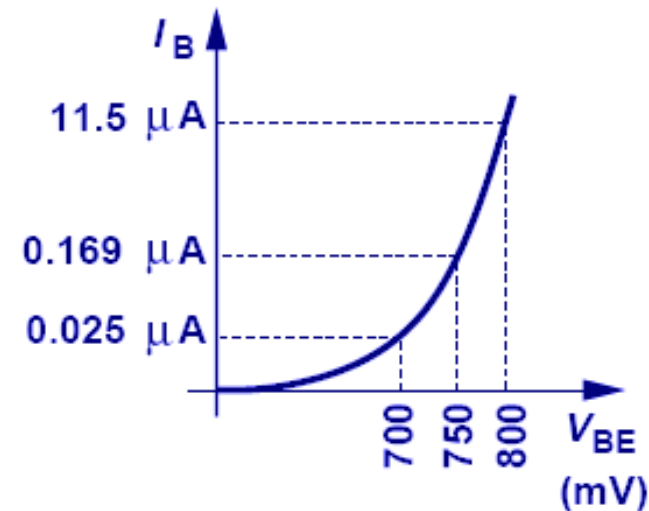
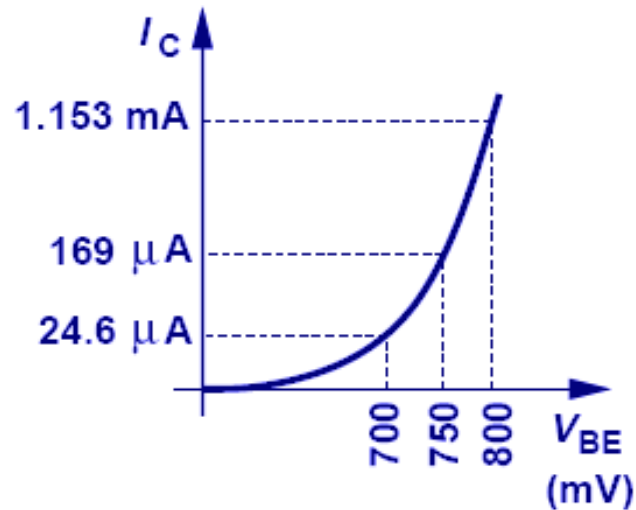
$$i_E = (\beta_F + 1)i_B$$

- Collector and emitter currents are almost equal ( $\alpha_F \approx 1$ )

$$\frac{i_C}{i_E} = \alpha_F$$

# BJT Current Amplifier

- A forward-active BJT is frequently used as an amplifier because a small amount of current in the base results in a much larger current in the collector
- Example I-V characteristics:  $\beta_F = 1000$ ,  $I_S = 5 \times 10^{-17} \text{ A}$ ,  $V_T = 26 \text{ mV}$ .



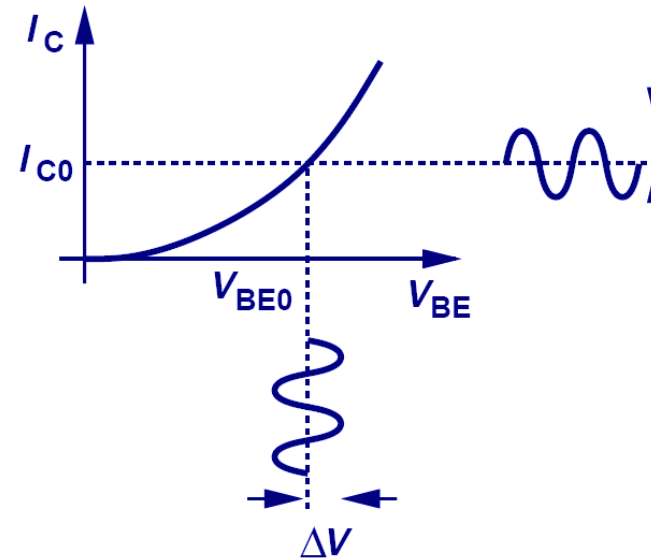
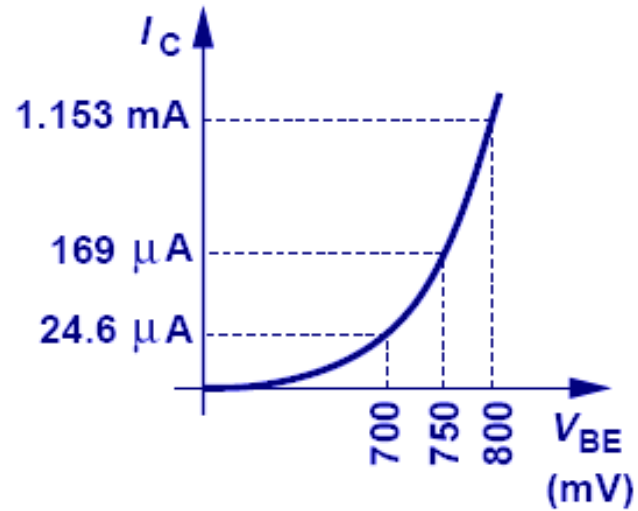
$$i_C = I_S \left[ \exp\left(\frac{V_{BE}}{V_T}\right) - 1 \right] \approx I_S \exp\left(\frac{V_{BE}}{V_T}\right)$$

$$i_B = \frac{i_C}{\beta_F}$$



# BJT Current Amplifier

- Then, a small **change** in current in the base results in a proportional change in current in the collector

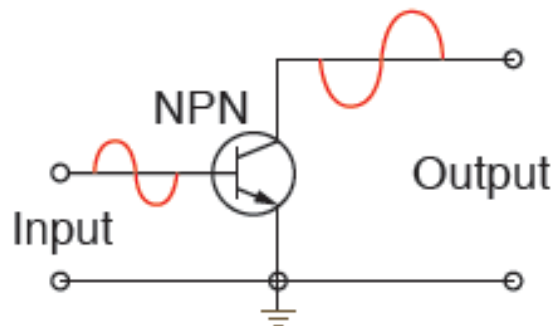


# BJT Configurations

- Different ways to configure a BJT when operating as an amplifier (forward active operation)

## ❑ Common Emitter

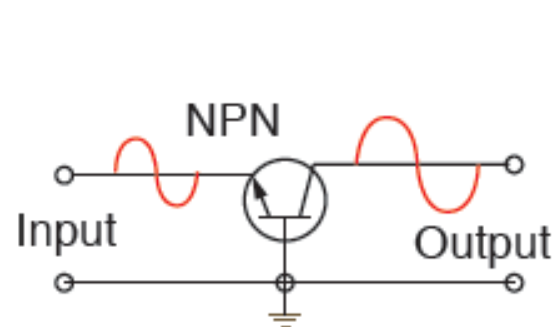
Emitter terminal is common between input and output side



$$\frac{i_C}{i_B} = \beta_F$$

## ❑ Common Base

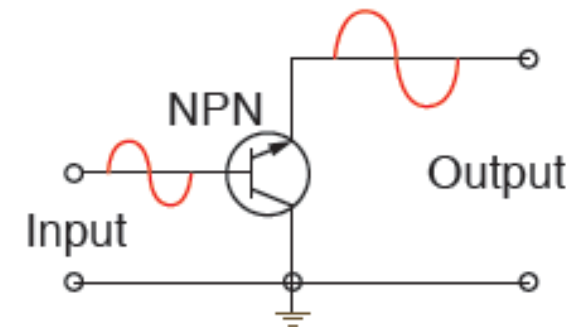
Base terminal is common between input and output side



$$\frac{i_C}{i_E} = \alpha_F$$

## ❑ Common Collector

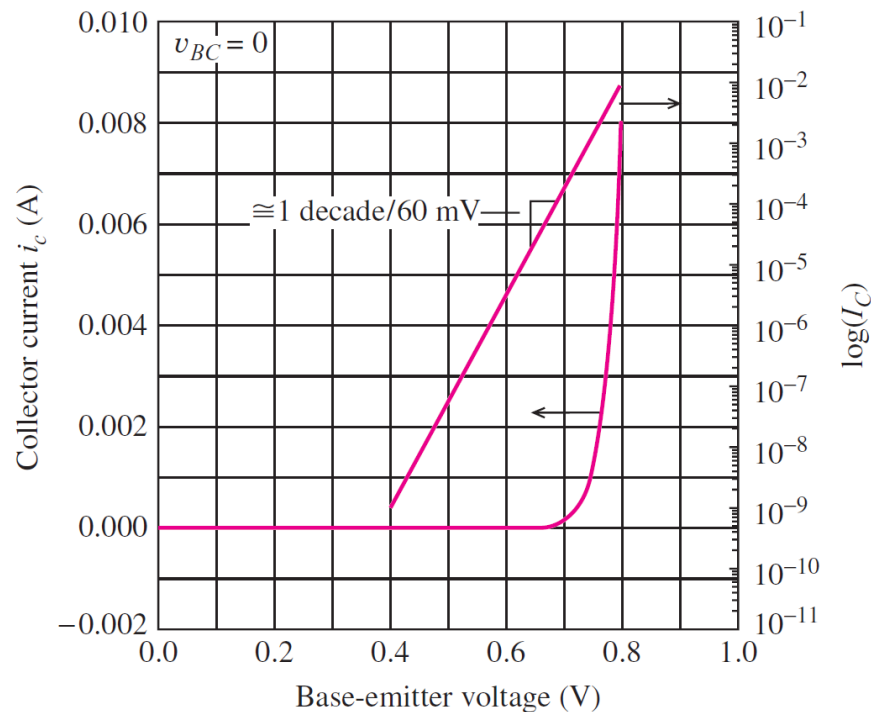
Collector terminal is common between input and output side



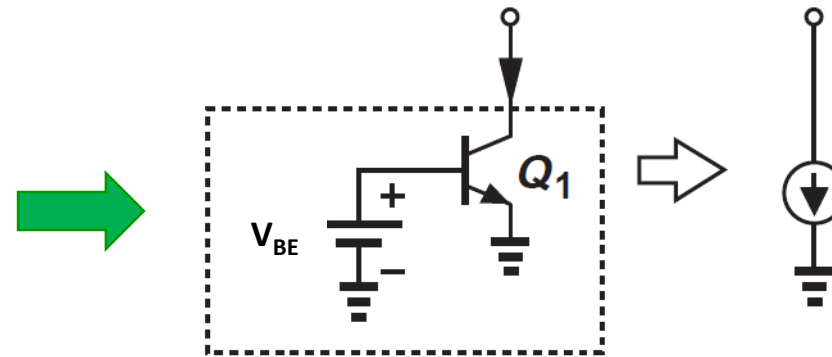
$$\frac{i_E}{i_B} = \beta_F + 1$$

# NPN Forward Active I-V Characteristics

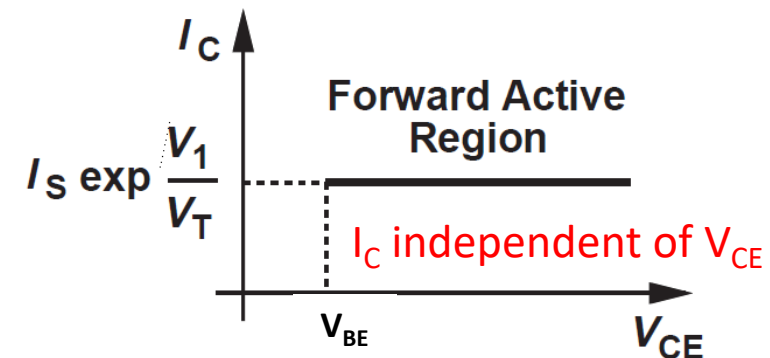
- Relation between collector current and base-emitter voltage of transistor.
- Almost identical to transfer characteristic of *pn* junction diode



$$i_C \approx I_S \exp\left(\frac{V_{BE}}{V_T}\right)$$

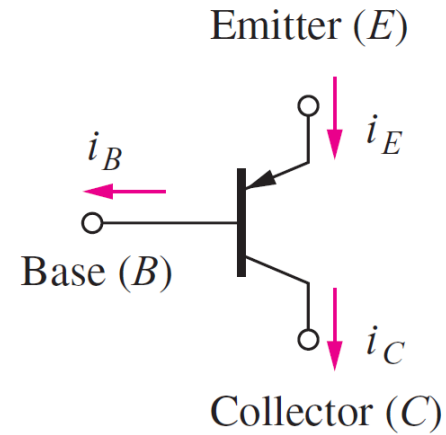
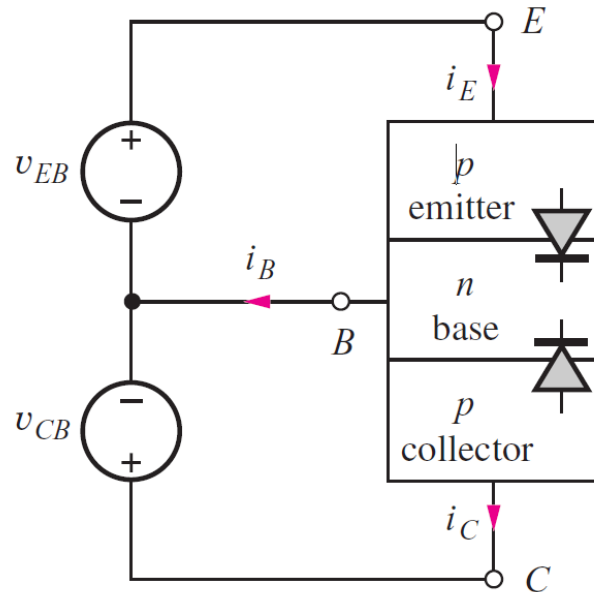


For a fixed  $V_{BE}$ , device acts like a constant current source, assuming B-C junction is not in breakdown.  $I_C$  independent of  $V_{CE}$



# PNP Forward Active Region

- PNP forward active region:  $V_{EB} > 0$ ,  $V_{CB} < 0$ 
  - Same concept as NPN, but bias voltages are opposite because the diodes are pointing in the opposite direction
  - Remember, for NPN in forward-active region:  $V_{BE} > 0$ ,  $V_{BC} < 0$ .
- Base-emitter is still forward-biased, base-collector is still reverse-biased



# PNP Forward Active Region

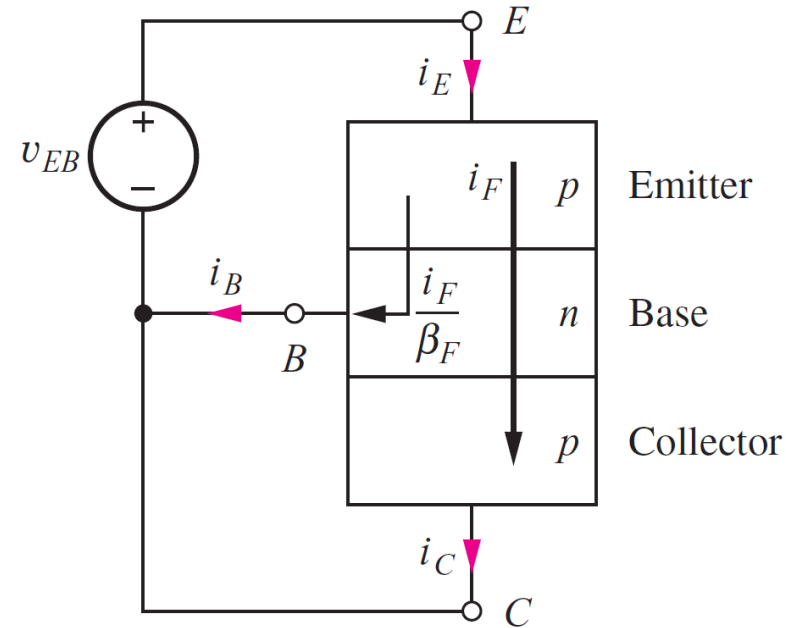
- These are all exactly the same as those for NPN transistors
- The only difference is that the voltages and currents are referenced in the opposite direction

$$i_C = i_F = I_S \left[ \exp \left( \frac{V_{EB}}{V_T} \right) - 1 \right]$$

$$i_B = \frac{I_S}{\beta_F} \left[ \exp \left( \frac{V_{EB}}{V_T} \right) - 1 \right]$$

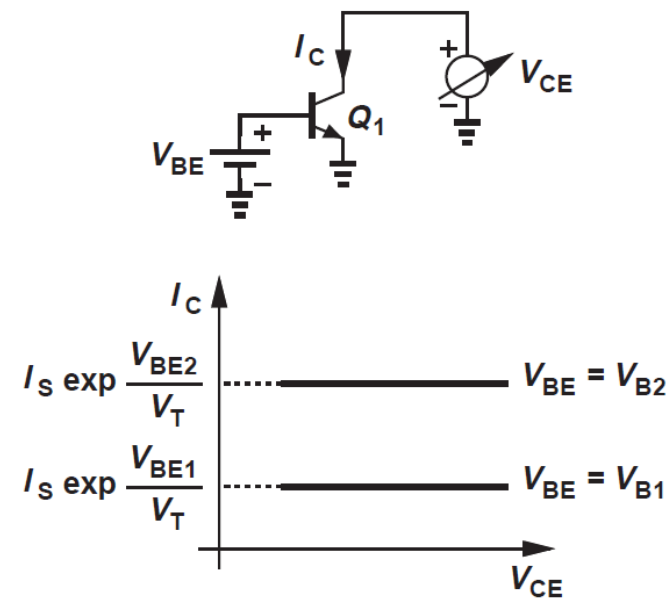
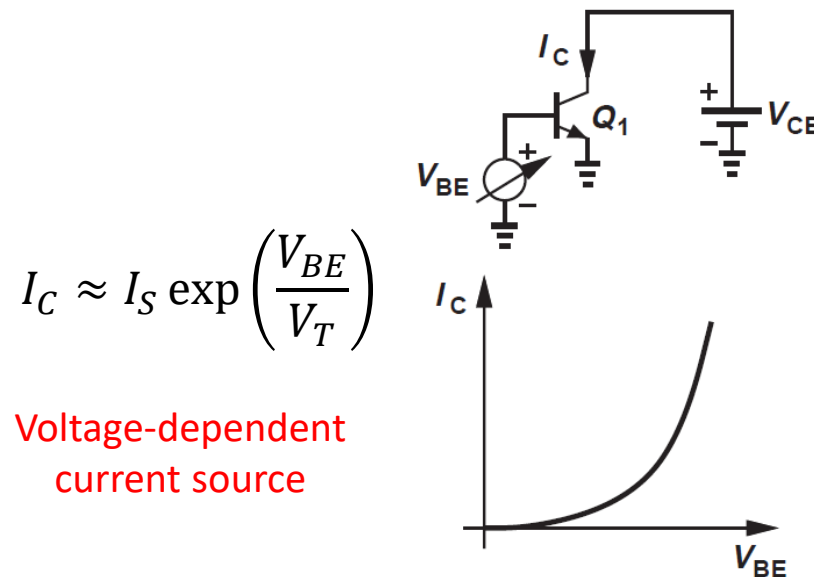
$$i_E = i_C + i_B$$

$$\frac{i_C}{i_B} = \beta_F \quad \frac{i_C}{i_E} = \alpha_F$$



# Summary of I/V characteristics in BJT

- Principal characteristics of interest
- For collector current:



$V_{CE}$  doesn't matter  
(as long as BC  
junction is reverse  
biased and not in  
breakdown)

- Base and emitter current follows the same behaviour:

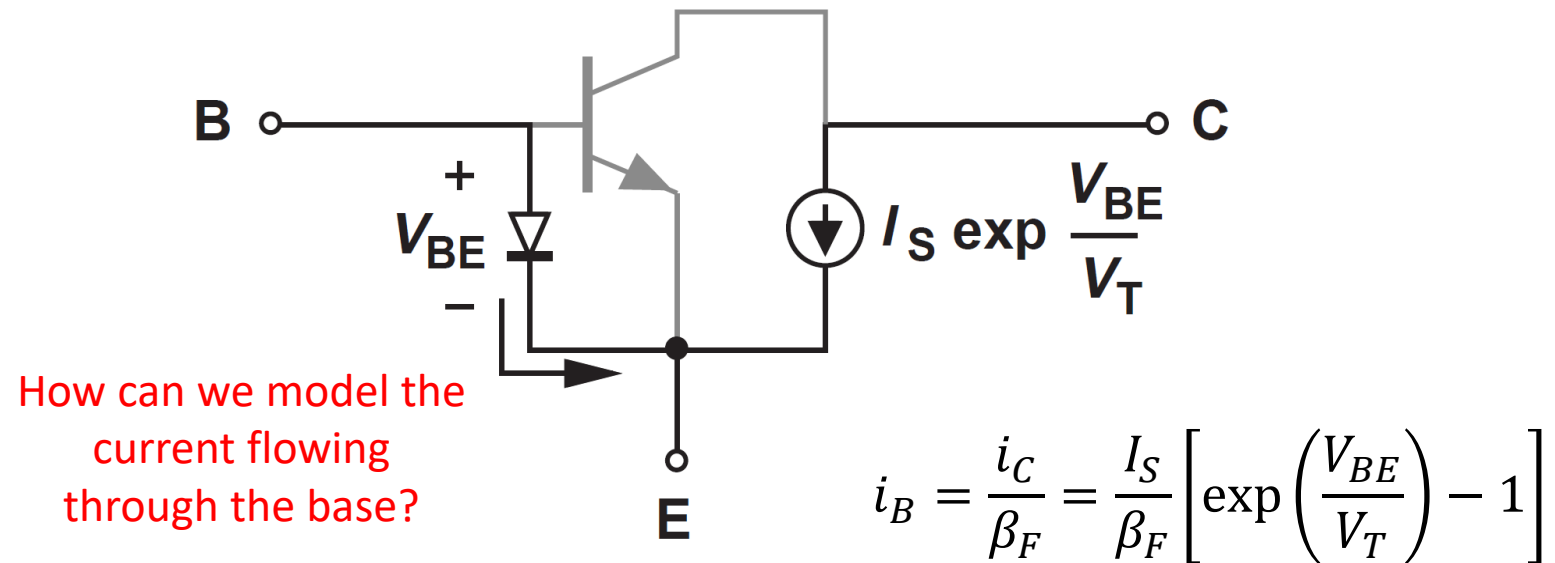
$$I_B = \frac{I_C}{\beta}$$

$$I_E = \frac{\beta + 1}{\beta} I_C$$

# BJT Large signal model

# BJT Large Signal Model

- Large-signal circuit analysis deals with inputs which have such a large range that devices cannot be turned into linear models
- Time to construct a model that will be useful for analysis and circuit designs:

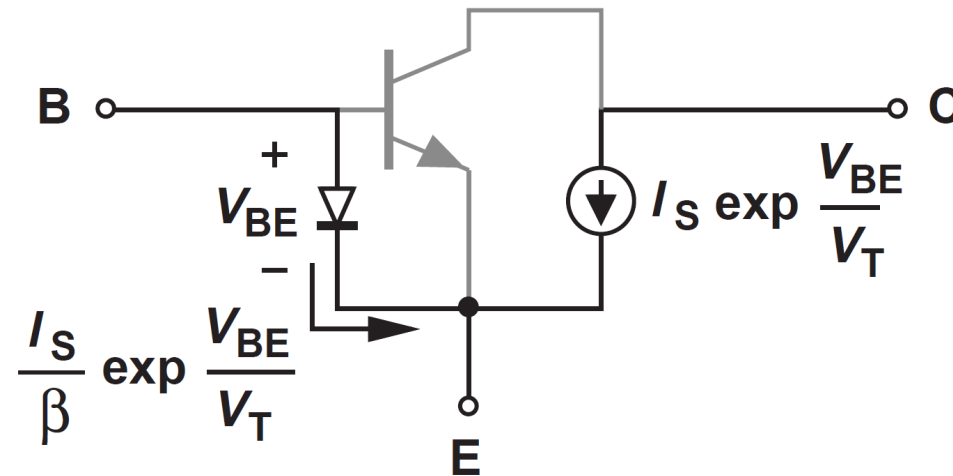


- A virtual diode placed between base and emitter terminals
- A virtual voltage controlled current source is placed between the collector and emitter



# BJT Large Signal Model

- Base-emitter junction is modelled by a diode whose cross section is  $1/\beta$  times that of the actual emitter area



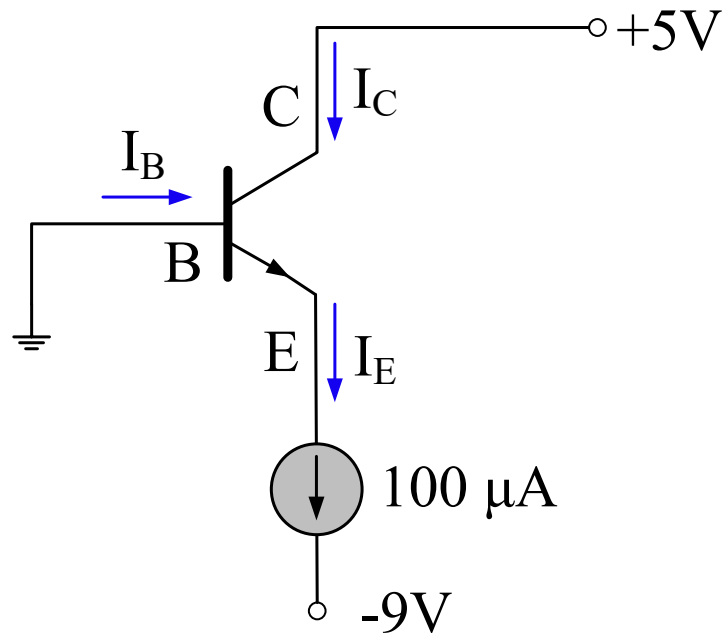
- The chain of dependencies of currents and voltages in a bipolar transistor:

$$V_{BE} \rightarrow I_C \rightarrow I_B \rightarrow I_E$$

# Large Signal Circuit Analysis

**Example 1:** Estimate terminal currents and base-emitter voltage for the following circuit.

Let  $I_S = 10^{-16} A$ ,  $\alpha_F = 0.95$ ,  $V_{BC} = V_B - V_C = -5 V$ ,  $I_E = 100 \mu A$ ,  $V_T = 25 mV$



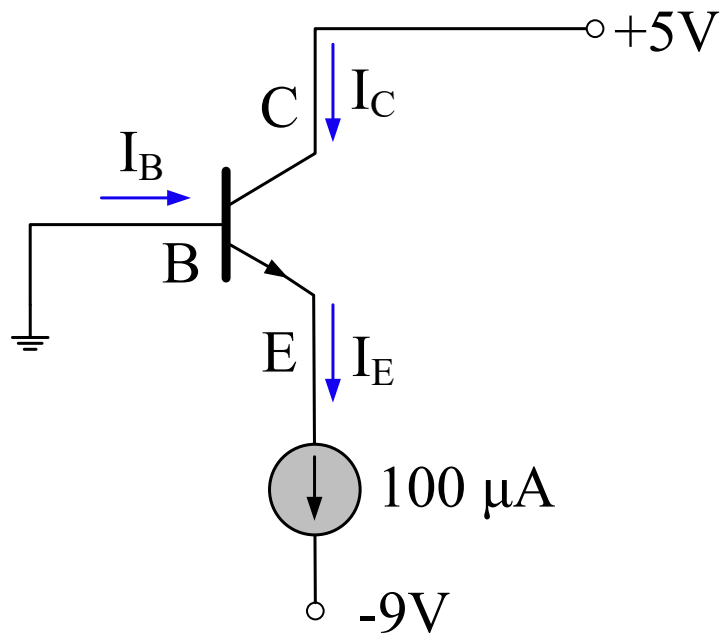
## Observations:

1. There is a current source at the emitter terminal
2. The base-emitter diode must be forward-biased, and  $V_{BE} > 0$
3.  $V_{BC} < 0$ , base-collector is reverse-biased.
4. The transistor is in forward-active operation region.

# Large Signal Circuit Analysis

Parameters given:

$$I_S = 10^{-16} A, \alpha_F = 0.95, V_{BC} = V_B - V_C = -5 V, I_E = 100 \mu A, V_T = 25 mV$$



$$I_C = \alpha_F I_E = 0.95 \times 100 \mu A = 95 \mu A$$

$$\beta_F = \frac{\alpha_F}{1 - \alpha_F} = \frac{0.95}{1 - 0.95} = 19$$

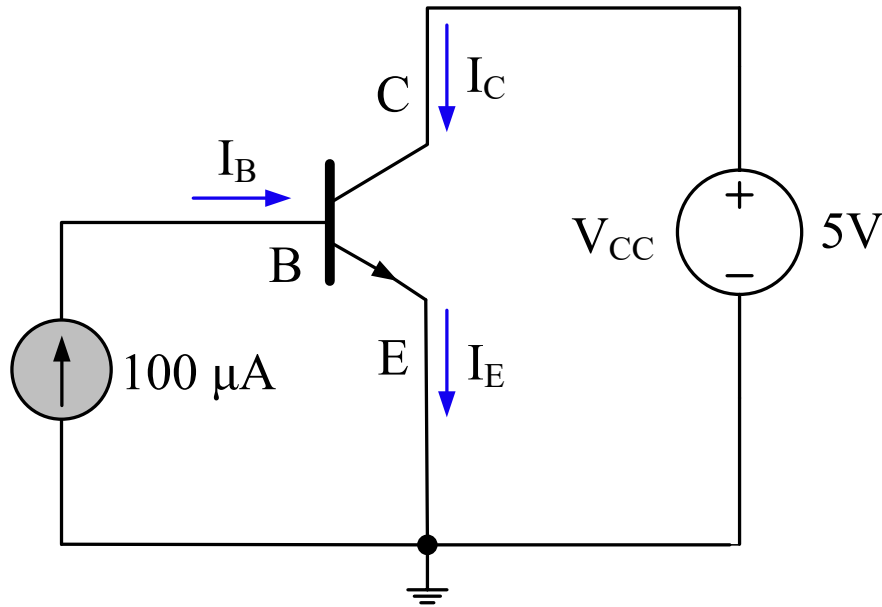
$$I_B = \frac{I_E}{\beta_F + 1} = \frac{100 \mu A}{19 + 1} = 5 \mu A$$

$$V_{BE} = V_T \ln \left( \frac{\alpha_F I_E}{I_S} \right) = 0.69 V$$

# Large Signal Circuit Analysis

**Example 2:** Estimate terminal currents, base-emitter, and base-collector voltage for the following circuit.

Let  $I_S = 10^{-16} A$ ,  $\alpha_F = 0.95$ ,  $V_C = +5 V$ ,  $I_B = 100 \mu A$ ,  $V_T = 25 mV$



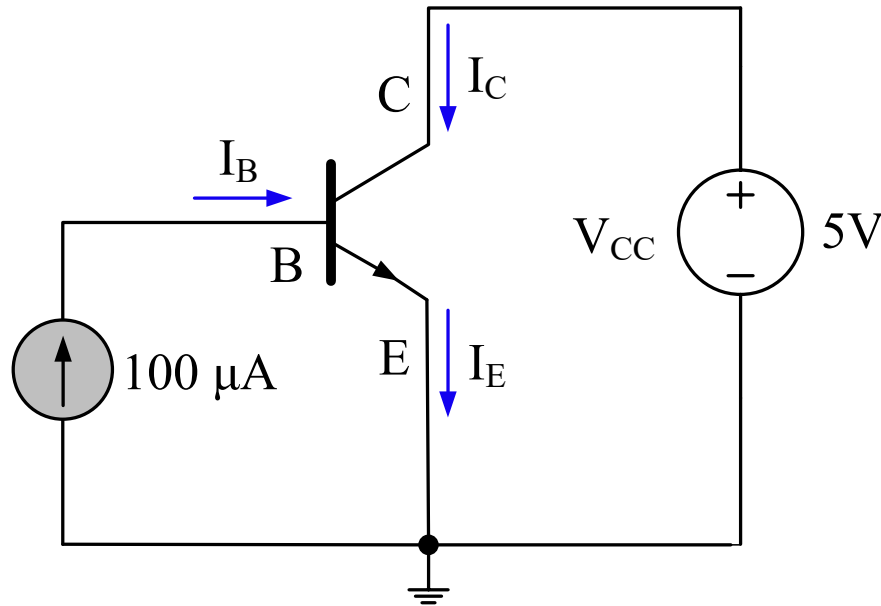
## Observations:

1. There is a current source going into the base
2. The base-emitter diode must be forward-biased, and  $V_{BE} > 0$
3. Base-collector is reverse-biased.
4. The transistor is in forward-active operation region.

# Large Signal Circuit Analysis

Parameters given:

$$I_S = 10^{-16} A, \alpha_F = 0.95, V_C = +5 V, I_B = 100 \mu A, V_T = 25 mV$$



$$I_C = \beta_F I_B = 19 \times 100 \mu A = 1.9 mA$$

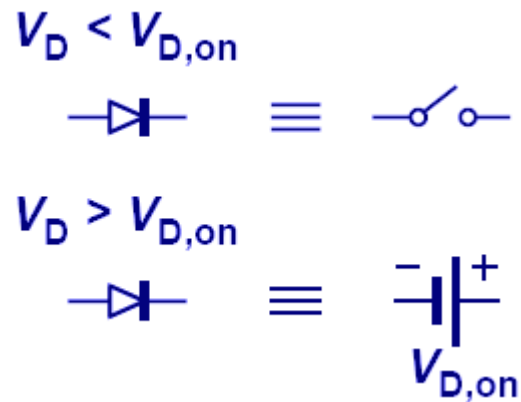
$$\begin{aligned} I_E &= (\beta_F + 1) I_B \\ &= 20 \times 100 \mu A = 2 mA \end{aligned}$$

$$V_{BE} = V_T \ln \left( \frac{I_C}{I_S} \right) = 0.764 V$$

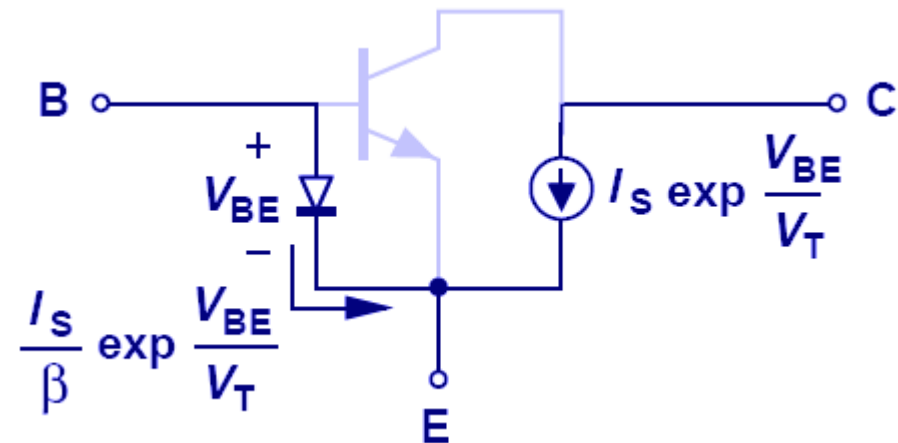
$$\begin{aligned} V_{BC} &= V_B - V_C = V_{BE} - V_C \\ &= 0.764 V - 5 = -4.24 V \end{aligned}$$

# BJT Model

- To further simplify the model,
  - Replace diode with a **constant-voltage diode** model
- When analyzing circuits, you must determine that the base-emitter junction is forward-biased before applying this model



CVD diode model

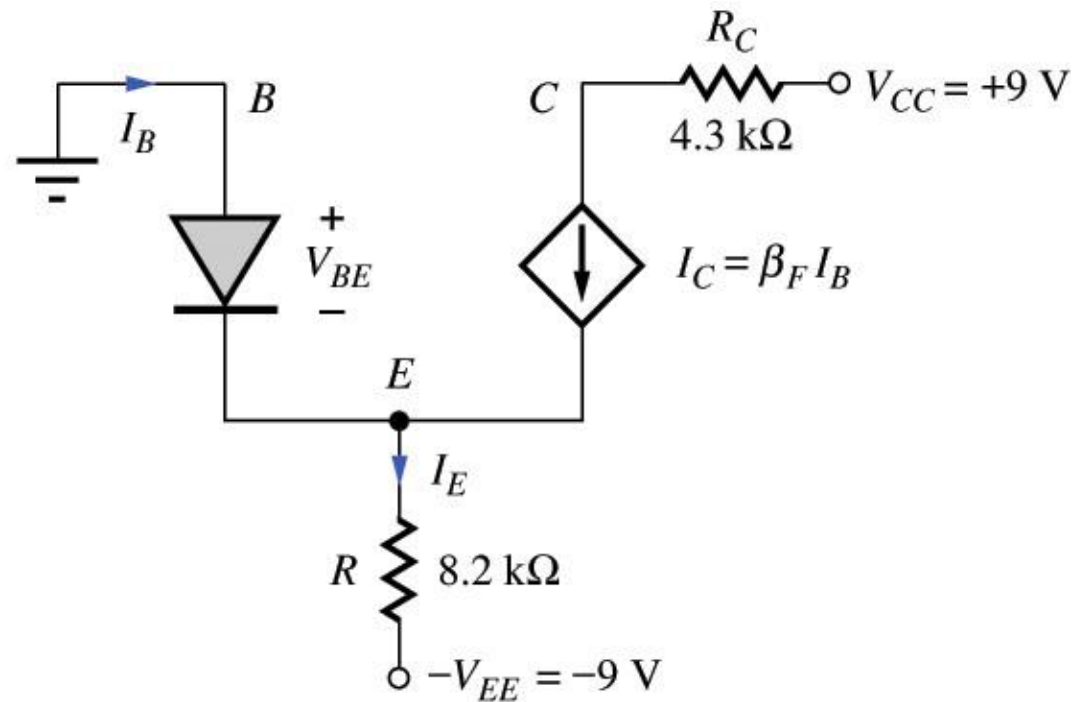
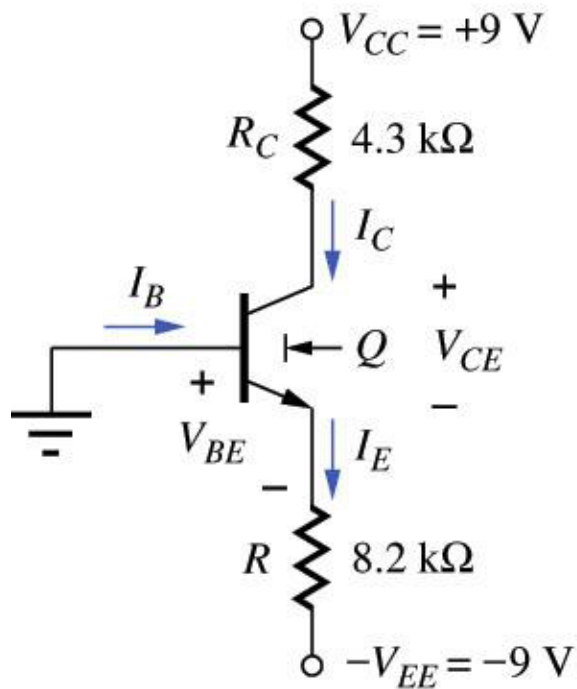


BJT model

# BJT Analysis

**Example:** Find Q-point for the following circuit. Let  $\beta_F = 50$ ,  $V_{BC} = -9\text{ V}$ ,  $V_{D,on} = 0.7\text{ V}$

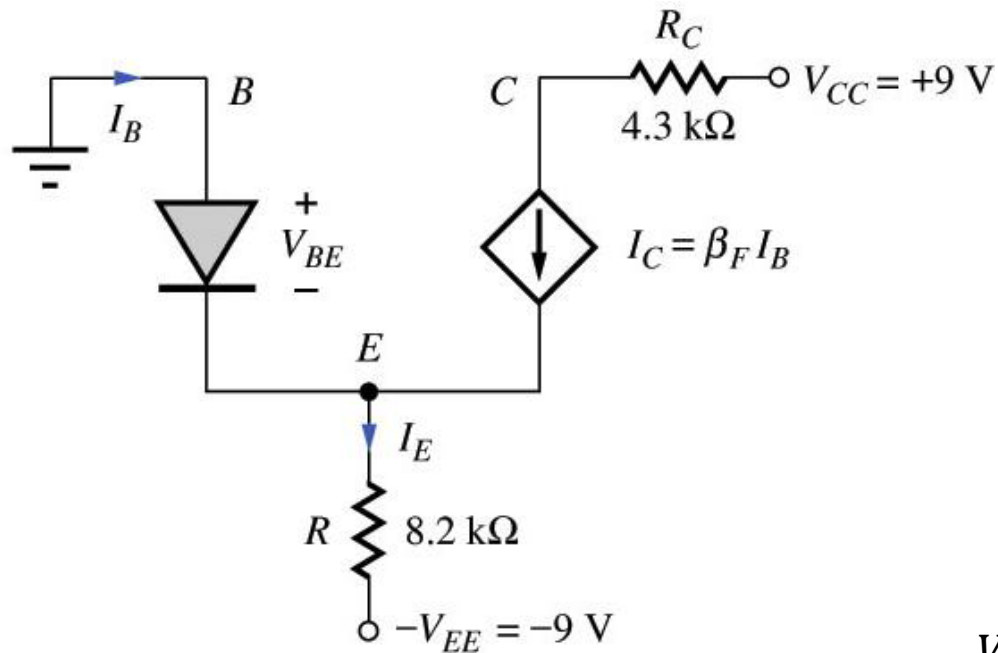
Assume transistor is in the forward-active operation. Then we can replace the BJT with a diode and a current source for large signal analysis.



# BJT Analysis

Parameters given:  $\beta_F = 50$ ,  $V_{BC} = -9\text{ V}$ ,  $V_{D,on} = 0.7\text{ V}$

Assume transistor is in the forward-active operation.



$$V_{BE} + 8200I_E - V_{EE} = 0$$

Assume CVD for BE junction,  $V_{BE} = V_{D,on} = 0.7\text{ V}$

$$I_E = \frac{V_{EE} - V_{BE}}{8200} = \frac{8.3}{8200} = 1.01\text{ mA}$$

$$I_B = \frac{I_E}{\beta_F + 1} = 19.8\text{ }\mu\text{A}$$

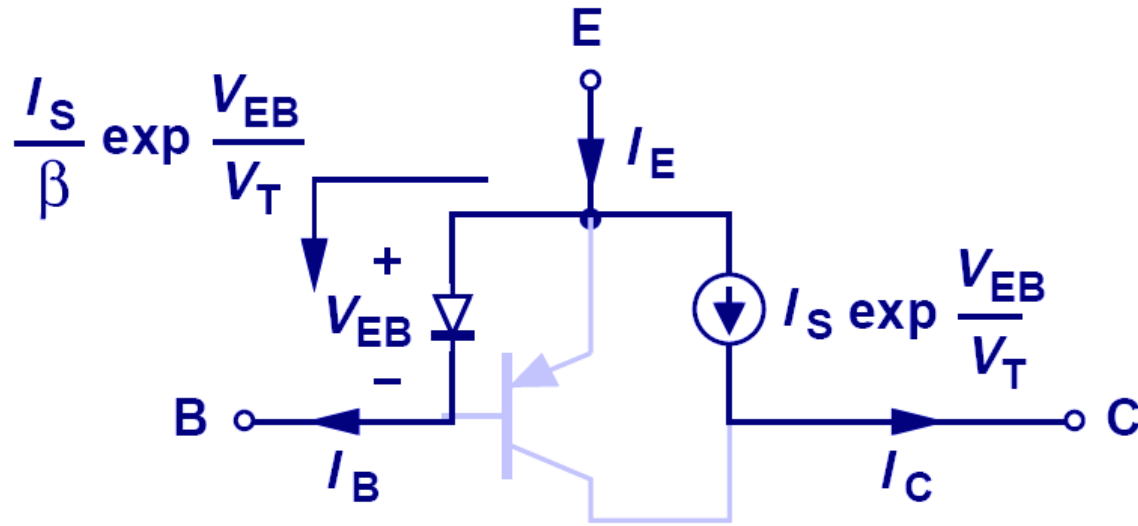
$$I_C = \beta_F I_B = 0.990\text{ mA}$$

$$V_{CE} = V_{CC} - I_C R_C - (-V_{BE}) = 5.44\text{ V}$$



# PNP Large Signal Model

- Exact same model as NPN, but currents and voltages are flipped



$$I_C = I_S \exp \frac{V_{EB}}{V_T}$$

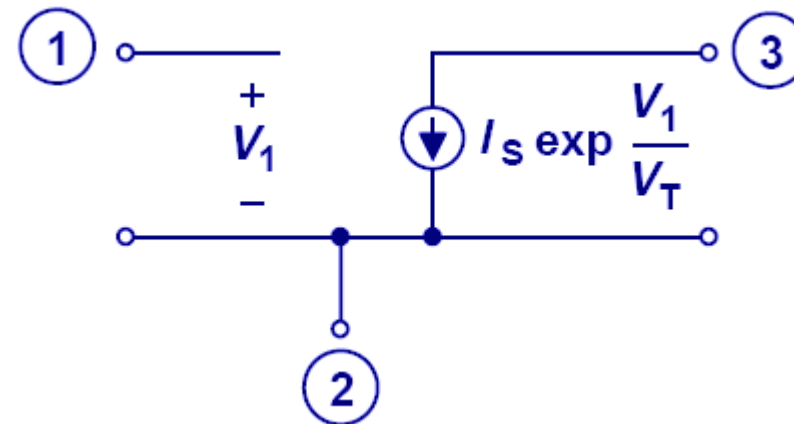
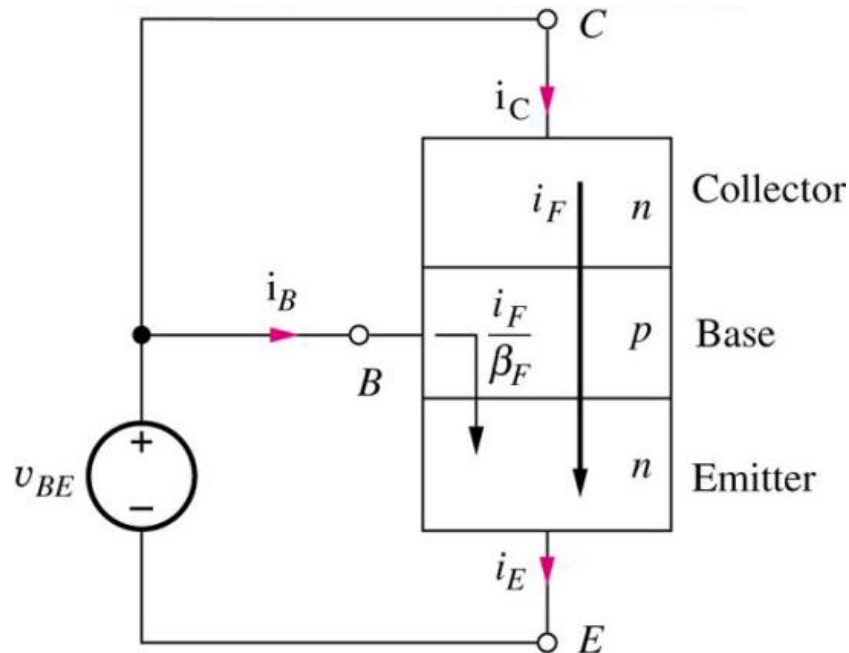
$$I_B = \frac{I_S}{\beta} \exp \frac{V_{EB}}{V_T}$$

$$I_E = \frac{\beta + 1}{\beta} I_S \exp \frac{V_{EB}}{V_T}$$

# BJT small signal analysis

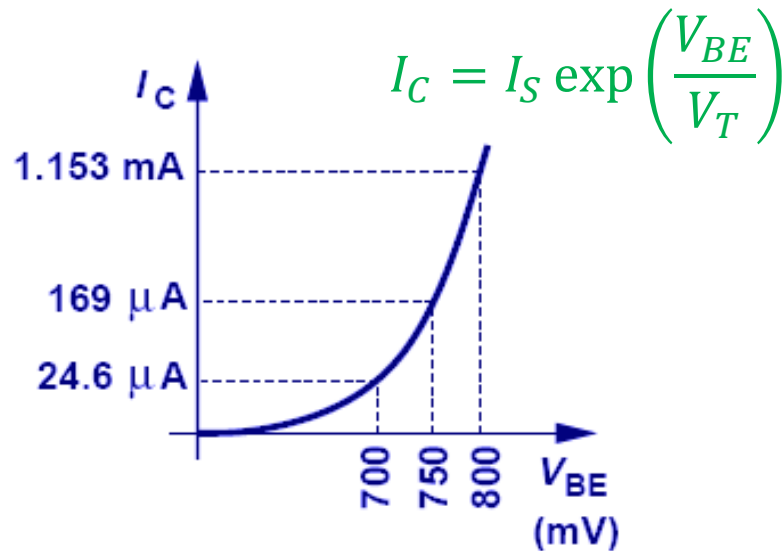
# BJT as Voltage-Controlled Current Source

- BJT can be modeled as a 3-terminal voltage-controlled current source
- Exponentials are a hassle
- If we keep the device operating around a given point with only small changes in the signal, we can create a linear model.

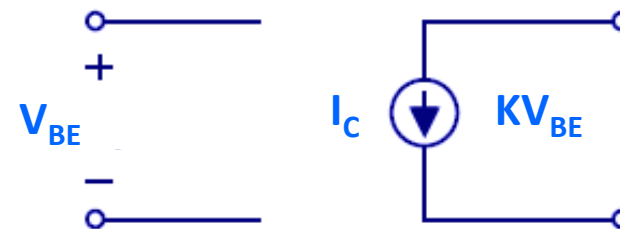
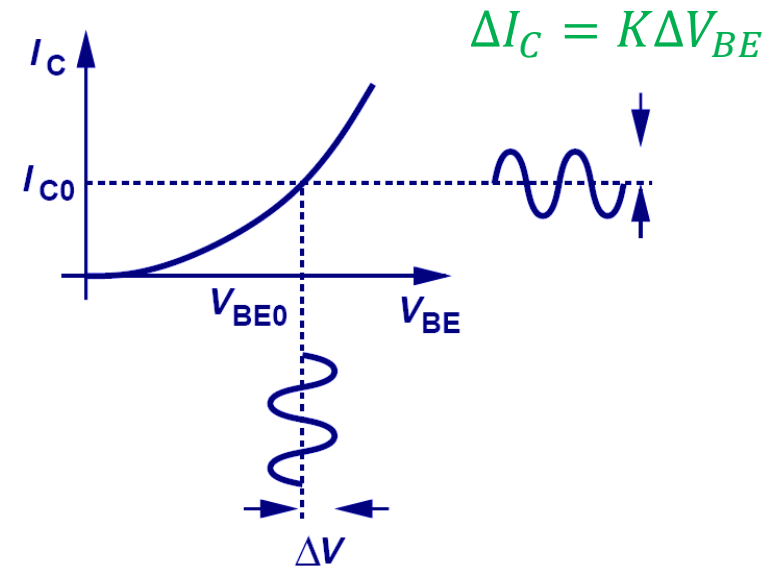


# BJT as Voltage-Controlled Current Source

- The relationship between  $V_{BE}$  and  $I_C$  is approximately linear when looking at small signals

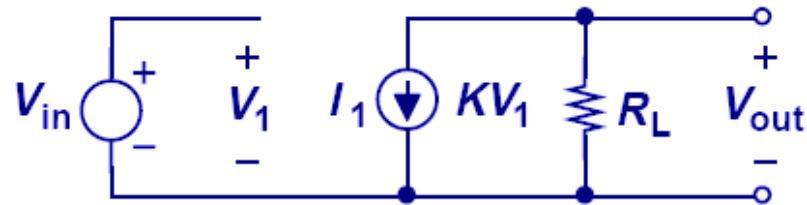


K represents some constant relation between  $\Delta V_{BE}$  and  $\Delta I_C$



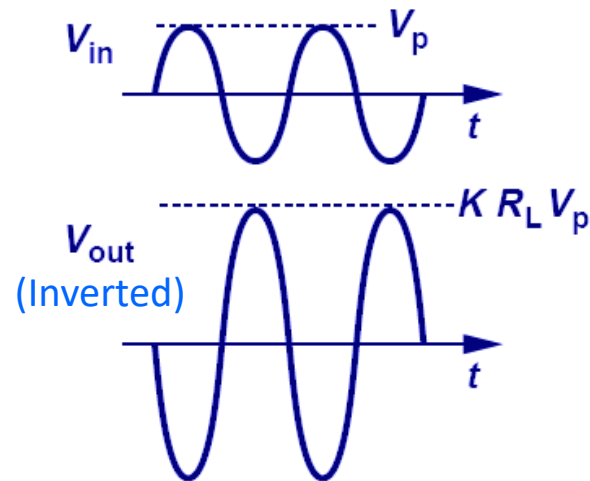
# BJT as Voltage-Controlled Current Source

- Output voltage can be measured across an output load



$$v_{out} = -Kv_{in}R_L$$

- If  $KR_L$  is greater than 1, then the signal is amplified

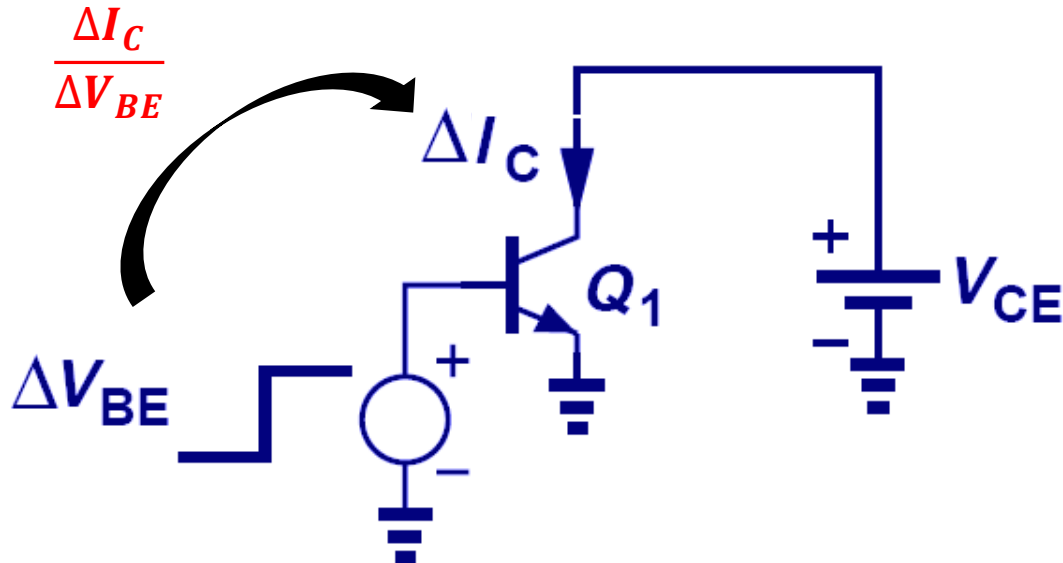


$$A_V = \frac{v_{out}}{v_{in}} = -KR_L$$

- How to quantify the device performance?
- How well can the voltage control the current source?
- What is  $K$ ?

# BJT Transconductance

- Transconductance,  $g_m$  is a small-signal measure of how well the transistor converts voltage to current.
- **$g_m$  is one of the most important parameters** in circuit design.
- Remember, for large-signal analysis, conductance  $G = 1/R$



For small changes:

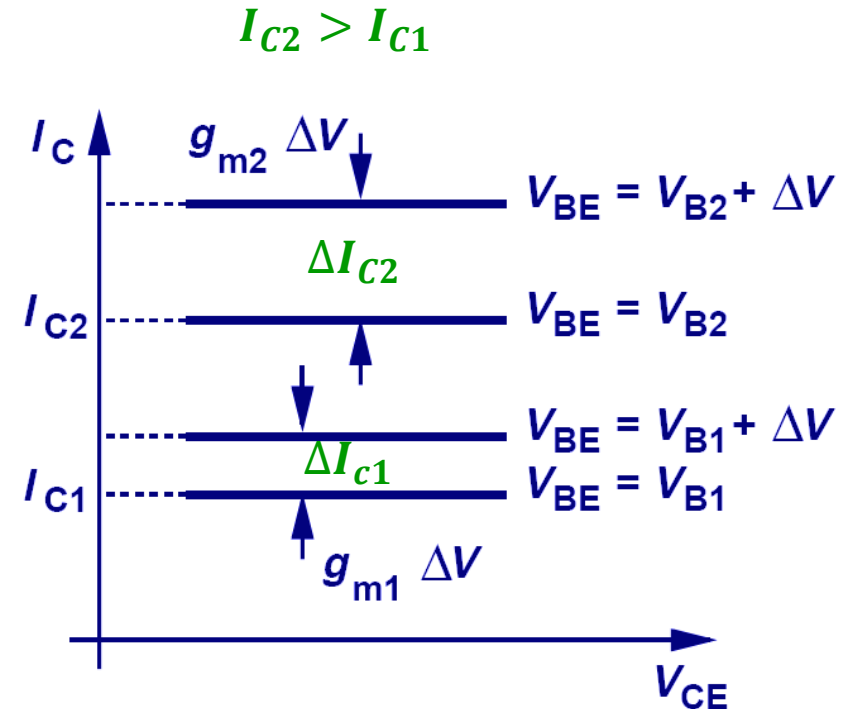
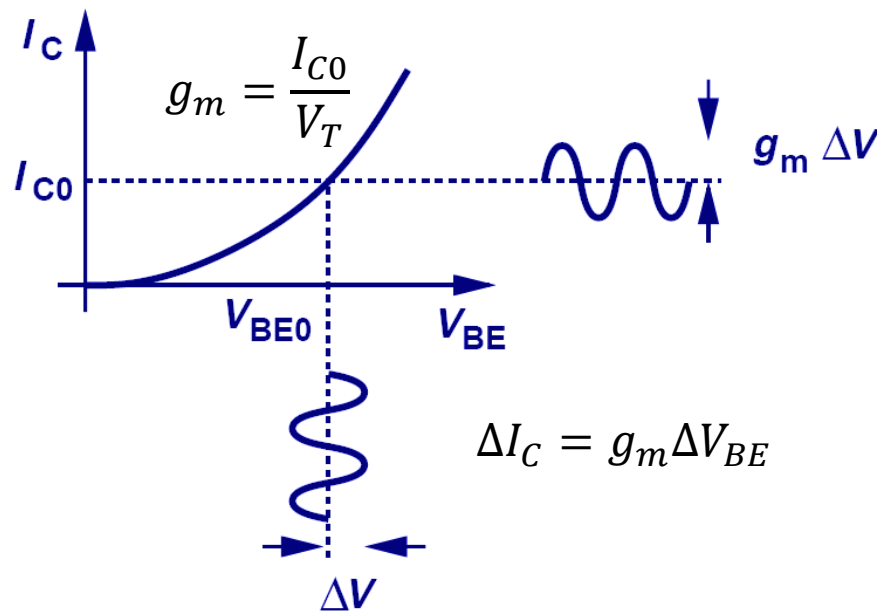
$$g_m = \frac{dI_C}{dV_{BE}} = \frac{d}{dV_{BE}} \left( I_S \exp \frac{V_{BE}}{V_T} \right)$$

$$g_m = \frac{1}{V_T} \left( I_S \exp \frac{V_{BE}}{V_T} \right)$$

$$g_m = \frac{I_C}{V_T}$$

# BJT Transconductance

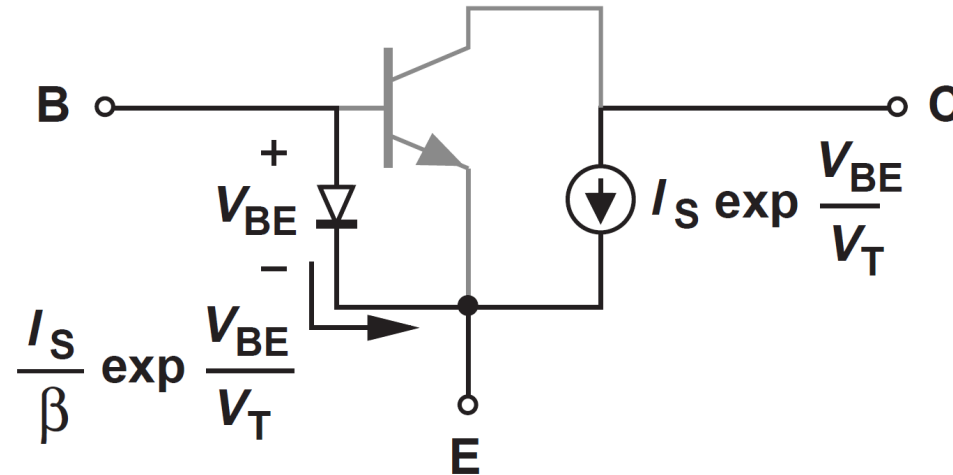
- $g_m$  can be visualized as the slope of  $I_C$  versus  $V_{BE}$  characteristics at a given collector current  $I_{C0}$  and base-emitter voltage  $V_{BE0}$
- A large  $g_m$  will cause a large change in  $I_C$  for the same change in  $\Delta V_{BE}$



# BJT Transconductance

## Question:

- If  $I_C$  remains constant, but  $\beta$  varies, does  $g_m$  change?



$$g_m = \frac{I_C}{V_T}$$

So, no.

$$\beta \nearrow, I_B \searrow$$

- Collector bias (or quiescent) current plays an important role in the design of BJT amplifiers